

6 Series LPD LPD64

**Specifications and Performance Verification** 

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# **Contents**

List of Figures	5
List of Tables	6
Important safety information	7
General safety summary	7
To avoid fire or personal injury	7
Probes and test leads	9
Service safety summary	10
Terms in this manual	10
Terms on the product	10
Symbols on the product	11
Specifications	12
Analog channel input and vertical specification	12
Timebase system	20
Trigger system	22
Serial Trigger specifications	25
Digital volt meter (DVM)	26
Trigger frequency counter	26
Arbitrary function generator	26
Processor system	29
Input/Output port specifications	29
Data storage specifications	31
Power supply system	32
Safety characteristics	32
Environmental specifications	32
Mechanical specifications	33
Performance verification procedures	34
Test records	35
DC Balance test record	35
DC Offset Accuracy test record	37
DC Gain Accuracy test record	38
Analog Bandwidth test record	40
Random Noise, sample acquisition mode test record	41
Random Noise, High Res mode test record	45
High Offset AC RMS Noise, sample acquisition mode test record	57
High Offset AC RMS Noise, High Res mode test record	61
Performance tests	78
Prerequisites	78
Self test	78
Check input impedance	79
Check DC balance	80
Check DC gain accuracy	81
Check DC offset accuracy	
Check analog bandwidth	
Check random noise, Sample acquisition mode (8 and 6 GHz options)	86

Check random noise, High Res mode	87
Check high offset AC RMS noise, Sample acquisition mode (8 and 6 GHz options)	
Check high offset AC RMS noise, High Res mode	89
Check long term samples rate and delay time accuracy	90
Check AUX Out output voltage levels	
Check DVM voltage accuracy (DC)	91
Check trigger frequency accuracy and maximum input frequency	92
Check AFG sine and ramp frequency accuracy	93
Check AFG square and pulse frequency accuracy	94
Check AFG signal amplitude accuracy	95
Check AFG DC offset accuracy	96

# **List of Figures**

Figure 1: Frequency/period test	93
Figure 2: Frequency/period test	94
Figure 3: 50 Ω terminator accuracy	95
Figure 4: Amplitude test	
Figure 5: 50 Ω terminator accuracy	
Figure 6: DC offset tests	97

# **List of Tables**

Table 1: 25 GS/s, Sample Mode, RMS	18
Table 2: 12.5 GS/s, HiRes Mode, RMS	18
Table 3: 25 GS/s, Sample Mode, RMS	18
Table 4: 12.5 GS/s, HiRes Mode, RMS	18
Table 5: 25 GS/s, Sample Mode, RMS	19
Table 6: 12.5 GS/s, HiRes Mode, RMS	19
Table 7: Gain expected worksheet	82
Table 8: CF (Calibration Factor) = 1.414 × ((50 / Measurement Ω) + 1)	95
Table 9: CF (Calibration Factor) = 0.5 × (( 50 / Measurement Ω) + 1)	96

# Important safety information

This manual contains information and warnings that must be followed by the user for safe operation and to keep the product in a safe condition.

To safely perform service on this product, see the Service safety summary that follows the General safety summary.

### **General safety summary**

Use the product only as specified. Review the following safety precautions to avoid injury and prevent damage to this product or any products connected to it. Carefully read all instructions. Retain these instructions for future reference.

This product shall be used in accordance with local and national codes.

For correct and safe operation of the product, it is essential that you follow generally accepted safety procedures in addition to the safety precautions specified in this manual.

The product is designed to be used by trained personnel only.

Only qualified personnel who are aware of the hazards involved should remove the cover for repair, maintenance, or adjustment.

Before use, always check the product with a known source to be sure it is operating correctly.

This product is not intended for detection of hazardous voltages.

Use personal protective equipment to prevent shock and arc blast injury where hazardous live conductors are exposed.

While using this product, you may need to access other parts of a larger system. Read the safety sections of the other component manuals for warnings and cautions related to operating the system.

When incorporating this equipment into a system, the safety of that system is the responsibility of the assembler of the system.

### To avoid fire or personal injury

#### Use proper power cord

Use only the power cord specified for this product and certified for the country of use. Do not use the provided power cord for other products.

#### **Ground the product**

This product is grounded through the grounding conductor of the power cord. To avoid electric shock, the grounding conductor must be connected to earth ground. Before making connections to the input or output terminals of the product, ensure that the product is properly grounded. Do not disable the power cord grounding connection.

#### Power disconnect

The power cord disconnects the product from the power source. See instructions for the location. Do not position the equipment so that it is difficult to operate the power cord; it must remain accessible to the user at all times to allow for quick disconnection if needed.

#### Connect and disconnect properly

Do not connect or disconnect probes or test leads while they are connected to a voltage source.

Use only insulated voltage probes, test leads, and adapters supplied with the product, or indicated by Tektronix to be suitable for the product.

#### Observe all terminal ratings

To avoid fire or shock hazard, observe all rating and markings on the product. Consult the product manual for further ratings information before making connections to the product.

Do not exceed the Measurement Category (CAT) rating and voltage or current rating of the lowest rated individual component of a product, probe, or accessory. Use caution when using 1:1 test leads because the probe tip voltage is directly transmitted to the product.

Do not apply a potential to any terminal, including the common terminal, that exceeds the maximum rating of that terminal.

Do not float the common terminal above the rated voltage for that terminal.

The measuring terminals on this product are not rated for connection to mains or Category II, III, or IV circuits.

#### Do not operate without covers

Do not operate this product with covers or panels removed, or with the case open. Hazardous voltage exposure is possible.

#### Avoid exposed circuitry

Do not touch exposed connections and components when power is present.

#### Do not operate with suspected failures

If you suspect that there is damage to this product, have it inspected by qualified service personnel.

Disable the product if it is damaged. Do not use the product if it is damaged or operates incorrectly. If in doubt about safety of the product, turn it off and disconnect the power cord. Clearly mark the product to prevent its further operation.

Before use, inspect voltage probes, test leads, and accessories for mechanical damage and replace when damaged. Do not use probes or test leads if they are damaged, if there is exposed metal, or if a wear indicator shows.

Examine the exterior of the product before you use it. Look for cracks or missing pieces.

Use only specified replacement parts.

#### Do not operate in wet/damp conditions

Be aware that condensation may occur if a unit is moved from a cold to a warm environment.

#### Do not operate in an explosive atmosphere

#### Keep product surfaces clean and dry

Remove the input signals before you clean the product.

#### Provide proper ventilation

Refer to the installation instructions in the manual for details on installing the product so it has proper ventilation.

Slots and openings are provided for ventilation and should never be covered or otherwise obstructed. Do not push objects into any of the openings.

#### Provide a safe working environment

Always place the product in a location convenient for viewing the display and indicators.

Avoid improper or prolonged use of keyboards, pointers, and button pads. Improper or prolonged keyboard or pointer use may result in serious injury.

Be sure your work area meets applicable ergonomic standards. Consult with an ergonomics professional to avoid stress injuries.

Use care when lifting and carrying the product. This product is provided with a handle or handles for lifting and carrying.



**WARNING:** The product is heavy. To reduce the risk of personal injury or damage to the device get help when lifting or carrying the product.

Use only the Tektronix rackmount hardware specified for this product.

### Probes and test leads

Before connecting probes or test leads, connect the power cord from the power connector to a properly grounded power outlet.

Keep fingers behind the protective barrier, protective finger guard, or tactile indicator on the probes. Remove all probes, test leads and accessories that are not in use.

Use only correct Measurement Category (CAT), voltage, temperature, altitude, and amperage rated probes, test leads, and adapters for any measurement.

#### Beware of high voltages

Understand the voltage ratings for the probe you are using and do not exceed those ratings. Two ratings are important to know and understand:

- The maximum measurement voltage from the probe tip to the probe reference lead.
- The maximum floating voltage from the probe reference lead to earth ground.

These two voltage ratings depend on the probe and your application. Refer to the Specifications section of the manual for more information.



**WARNING:** To prevent electrical shock, do not exceed the maximum measurement or maximum floating voltage for the oscilloscope input BNC connector, probe tip, or probe reference lead.

#### Connect and disconnect properly.

Connect the probe output to the measurement product before connecting the probe to the circuit under test. Connect the probe reference lead to the circuit under test before connecting the probe input. Disconnect the probe input and the probe reference lead from the circuit under test before disconnecting the probe from the measurement product.

Connect the probe reference lead to earth ground only.

#### Inspect the probe and accessories

Before each use, inspect probe and accessories for damage (cuts, tears, or defects in the probe body, accessories, or cable jacket). Do not use if damaged.

#### Ground-referenced oscilloscope use

Do not float the reference lead of this probe when using with ground-referenced oscilloscopes. The reference lead must be connected to earth potential (0 V).

#### Floating measurement use

Do not float the reference lead of this probe above the rated float voltage.

### Service safety summary

The Service safety summary section contains additional information required to safely perform service on the product. Only qualified personnel should perform service procedures. Read this Service safety summary and the General safety summary before performing any service procedures.

#### To avoid electric shock

Do not touch exposed connections.

#### Do not service alone

Do not perform internal service or adjustments of this product unless another person capable of rendering first aid and resuscitation is present.

#### Disconnect power

To avoid electric shock, switch off the product power and disconnect the power cord from the mains power before removing any covers or panels, or opening the case for servicing.

#### Use care when servicing with power on

Dangerous voltages or currents may exist in this product. Disconnect power, remove battery (if applicable), and disconnect test leads before removing protective panels, soldering, or replacing components.

#### Verify safety after repair

Always recheck ground continuity and mains dielectric strength after performing a repair.

### Terms in this manual

These terms may appear in this manual:



WARNING: Warning statements identify conditions or practices that could result in injury or loss of life.



CAUTION: Caution statements identify conditions or practices that could result in damage to this product or other property.

### Terms on the product

These terms may appear on the product:

- DANGER indicates an injury hazard immediately accessible as you read the marking.
- WARNING indicates an injury hazard not immediately accessible as you read the marking.
- CAUTION indicates a hazard to property including the product.

# Symbols on the product



When this symbol is marked on the product, be sure to consult the manual to find out the nature of the potential hazards and any actions which have to be taken to avoid them. (This symbol may also be used to refer the user to ratings in the manual.)

The following symbols(s) may appear on the product.



CAUTION: Refer to Manual



Protective Ground (Earth) Terminal



Standby



Chassis Ground



Functional Earth Terminal

# **Specifications**

This chapter contains specifications for the instrument. All specifications are typical unless noted as guaranteed. Typical specifications are provided for your convenience but are not guaranteed. Specifications that are marked with the 🗸 symbol are guaranteed and checked in Performance Verification.

To meet specifications, these conditions must first be met:

- The instrument must have been calibrated in an ambient temperature between 18 °C and 28 °C (64 °F and 82 °F).
- The instrument must be operating within the environmental limits described in these specifications.
- The instrument must be powered from a source that meets the specifications.
- The instrument must have been operating continuously for at least 20 minutes within the specified operating temperature range.
- You must perform the Signal path compensation procedure after the warmup period. See the Signal path compensation procedure for how to perform signal path compensation. If the ambient temperature changes more than 5 °C (9 °F), repeat the procedure.

Warranted specifications describe guaranteed performance with tolerance limits or certain type-tested requirements.

### Analog channel input and vertical specification

Number of input channels

LPD64 4 SMA

DC Input coupling

Input resistance selection 50 Ω

✓ Input impedance 50  $\Omega$ , DC 50  $\Omega \pm 3\%$ 

coupled

Input VSWR, 50 Ω DC-coupled,

typical

Input frequency	VSWR < 100 mV/div	VSWR ≥100 mV/div
<5 GHz	1.45	1.2
≤8 GHz	1.95	1.7

Maximum input voltage, 50

Ohm

2.3  $V_{RMS}$  at <100 mV/division, with peaks  $\leq \pm 20 \text{ V}$ 

5.5 V<sub>RMS</sub> at >100 mV/division, with peaks ≤ ±20 V

DC balance ✓ 0.1 div with DC-50  $\Omega$  oscilloscope input impedance (50  $\Omega$  BNC terminated)

✓ 0.2 div at 1 mV/div with DC-50 Ω oscilloscope input impedance (50 Ω BNC terminated)

Number of digitized bits 8 bits at 25 GS/s; 8 GHz on all channels

12 bits at 12.5 GS/s; 4 GHz on all channels

13 bits at 6.25 GS/s (High Res); 2 GHz on all channels 14 bits at 3.125 GS/s (High Res); 1 GHz on all channels 15 bits at 1.25 GS/s (High Res); 500 MHz on all channels 16 bits at 625 MS/s (High Res); 500 MHz on all channels

For 12-bit mode, there are 4096 DL's (digitizing levels) in a captured waveform. For 8-bit mode, there are 256 DL's. DL is the abbreviation for digitization level. A DL is the smallest voltage level change that can be resolved by an A-D Converter. This value is also known as an LSB (least significant bit).

In an un-zoomed time-domain waveform plot, the full vertical scale of the plot (in 12-bit mode) is 4000 DLs ±48 DLs "off-screen" but are still available for measurements, analysis, and download.

In 8-bit mode, there are 250 DLs displayed. ±3 digitizing levels are "off-screen" but are still available for measurements, analysis, and download.

Sensitivity range, coarse

50 Ω 1 mV/div to 1 V/div in a 1-2-5 sequence

Sensitivity range, fine

50 Ω Allows continuous adjustment from:

1 mV/div to 1 V/div

Sensitivity resolution, fine

≤1% of current setting

DC gain accuracy

✓ 50 Ohm ±2.0% (±2.0% at 2 mV/div, ±4% at 1 mV/div, typical). Immediately following SPC, add 2% for every 5 °C

change in ambient.

 $\pm 1.0\%$  of full scale, ( $\pm 1.0\%$  of full scale at 2 mV/div,  $\pm 2\%$  at 1 mV/div, typical). Immediately following SPC, add

1% for every 5 °C change in ambient.

Offset ranges, maximum

Input signal cannot exceed maximum input voltage for the 50  $\Omega$  input path.

Volts/div Setting	Maximum offset range, 50 Ω Input		
1 mV/div - 99 mV/div	±1 V		
100 mV/div - 1 V/div	±10 V		

Position range ±5 divisions

✓ Offset accuracy ±(0.005 X | offset - position | + DC balance); Offset, position, and DC Balance in units of Volts)

Digital nonlinearity INL @ > 2 mV/div: ±16 DL's (12-bit reference)

INL @  $\leq$  2 mV/div:  $\pm$ 20 DL's (12-bit reference)

DNL: ±1.0 DL's (12-bit digitizing scale) when oscilloscope is in Hi-Res mode.

Number of waveforms for average acquisition mode

2 to 10,240 Waveforms, default 16 waveforms

DC voltage measurement accuracy, Average acquisition mode

	Measurement Type	DC Accuracy (In Volts)	
1		±((DC Gain Accuracy) *  reading - (offset - position)  + Offset Accuracy + 0.05 * V/div setting)	
	Table continued		

Measurement Type	DC Accuracy (In Volts)	
Delta volts between any two averages of ≥16 waveforms acquired with the same oscilloscope setup and ambient conditions	±(DC Gain Accuracy *  reading  + 0.1 div)	

DC voltage measurement accuracy, Sample acquisition mode, typical

Measurement Type	DC Accuracy (In Volts)		
Any Sample	±(DC Gain Accuracy *  reading - (offset - position)  + Offset Accuracy + 0.15+0.6 mV)		
Delta volts between any two samples acquired with the same scope setup and ambient conditions	±(DC Gain Accuracy *  reading  + 0.15 div +1.2 mV)		

#### **Bandwidth selections**

8 GHz model, 50 Ohm 20 MHz, 200 MHz, 250 MHz, 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5 GHz, 3 GHz, 4 GHz, 5 GHz, 6 GHz, 7

GHz, and 8 GHz

6 GHz model, 50 Ohm 20 MHz, 200 MHz, 250 MHz, 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5 GHz, 3 GHz, 4 GHz, 5 GHz, and 6 GHz

4 GHz model, 50 Ohm 20 MHz, 200 MHz, 250 MHz, 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5 GHz, 3 GHz, and 4 GHz

2.5 GHz model, 50 Ohm 20 MHz, 200 MHz, 250 MHz, 350 MHz, 500 MHz, 1 GHz, 2 GHz, and 2.5 GHz

1 GHz model, 50 Ohm 20 MHz, 200 MHz, 250 MHz, 350 MHz, 500 MHz, and 1 GHz

Frequency response tolerance/ ±0.5 dB from DC to 80% of bandwidth setting

flatness, 50 Ohm, all modes,

typical

Not valid for bandwidth settings ≤ 250 MHz or while using peak detect or envelope modes.

Phase response

±2.5 degrees, typical out to 7 GHz.

✓ Analog bandwidth 50 Ω DC coupled

Model	Volts/Div Setting	Bandwidth
LPD64 BW-8000	1 mV/div - 1V/div	DC - 8 GHz
LPD64 BW-6000	1 mV/div - 1V/div	DC - 6 GHz
LPD64 BW-4000	1 mV/div - 1V/div	DC - 4 GHz
LPD64 BW-2500	1 mV/div - 1V/div	DC - 2.5 GHz
LPD64 BW-1000	1 mV/div - 1V/div	DC - 1 GHz

The limits stated above are for ambient temperature of ≤ 30 °C and the bandwidth selection set to FULL. Reduce the upper bandwidth frequency by 1% for each °C above 30 °C.

Upper frequency limit, 250 MHz bandwidth limited, typical

250 MHz,  $\pm$  5% 50 Ω, DC-coupled

Upper frequency limit, 200 MHz bandwidth limited, typical

50 Ω, DC-coupled 200 MHz, ± 5%

#### Upper frequency limit, 20 MHz bandwidth limited, typical

50 Ω, DC-coupled

 $20~\text{MHz}, \pm 5\%$ 

Calculated rise time

Calculated Rise Time (10% to 90%) equals 0.4/BW

Model	50 Ω	TPP1000 Probe	
	1 mV-1 V	5 mV-10 V	
LPD64 BW-8000	50ps	400ps	
LPD64 BW-6000	66.67ps	400ps	
LPD64 BW-4000	100ps	400ps	
LPD64 BW-2500	160ps	400ps	
LPD64 BW-2000	200ps	400ps	
LPD64 BW-1000	400ps	400ps	

The formula is calculated by measuring -3 dB bandwidth of the oscilloscope. The formula accounts for the rise time contribution of the oscilloscope independent of the rise time of the signal source.

Peak Detect or Envelope mode pulse response, typical

Peak Detect or Envelope mode Minimum pulse width is >160 ps (25 GS/s)

Effective bits, 50  $\Omega$ , typical

50 mV/div, 25	50 mV/div, 25 GS/s, Sample Mode, 50 Ohm					
Frequency	Frequency					
Bandwidth	10 MHz	250 MHz	1 GHz	2 GHz	4 GHz	7 GHz
8 GHz	6.5	6.5	6.5	6.4	6.4	6.3
7 GHz	6.6	6.6	6.6	6.6	6.5	6.4
6 GHz	6.8	6.8	6.8	6.7	6.7	NA
5 GHz	7	7	6.9	6.9	6.8	NA

2 mV/div, 25 GS/s, Sample Mode, 50 Ohm									
Frequency									
Bandwidth	10 MHz	250 MHz	1 GHz	2 GHz	4 GHz	7 GHz			
8 GHz	5.1	5.1	5.1	5.1	5.1	5.1			
7 GHz	5.3	5.3	5.3	5.3	5.3	5.3			
6 GHz	5.5	5.5	5.5	5.5	5.5	NA			
5 GHz	5.65	5.65	5.65	5.65	5.65	NA			

50 mV/div, 12.5 GS/s, HiRes Mode, 50 Ohm									
Frequency									
Bandwidth	dwidth 10 MHz 250 MHz 1 GHz 2 GHz 4 GHz								
4 GHz	7.25	7.25	7.25	7.1	7				
3 GHz	7.5	7.5	7.5	7.35	NA				
Table continued.		1	'	'					

50 mV/div, 12.	5 GS/s, HiRes	Mode, 50 Ohm			
Frequency					
Bandwidth	10 MHz	250 MHz	1 GHz	2 GHz	4 GHz
2.5 GHz	7.6	7.6	7.6	7.4	NA
2 GHz	7.8	7.8	7.65	7.5	NA
1 GHz	8.2	8.2	8	NA	NA
500 MHz	8.5	8.5	NA	NA	NA
350 MHz	8.8	8.9	NA	NA	NA
250 MHz	8.9	9	NA	NA	NA
200 MHz	9	NA	NA	NA	NA
20 MHz	9.8	NA	NA	NA	NA

2 mV/div, 12.5	GS/s, HiRes M	ode, 50 Ohm			
Frequency					
Bandwidth	10 MHz	250 MHz	1 GHz	2 GHz	4 GHz
4 GHz	5.9	5.9	5.9	5.85	5.8
3 GHz	6.1	6.1	6.1	6.1	NA
2.5 GHz	6.2	6.2	6.2	6.2	NA
2 GHz	6.35	6.35	6.35	6.35	NA
1 GHz	6.8	6.8	6.8	NA	NA
500 MHz	7.2	7.2	NA	NA	NA
350 MHz	7.4	7.4	NA	NA	NA
250 MHz	7.5	7.5	NA	NA	NA
200 MHz	7.75	NA	NA	NA	NA
20 MHz	8.8	NA	NA	NA	NA

### Effective bits, 50 $\boldsymbol{\Omega}$

50 mV/div, 25 GS/s, Sample Mode, 50 Ohm									
Frequency									
Bandwidth	10 MHz	250 MHz	1 GHz	2 GHz	4 GHz	7 GHz			
8 GHz	6.06	6.06	6.06	5.97	5.97	5.88			
7 GHz	6.15	6.15	6.15	6.15	6.06	5.97			
6 GHz	6.32	6.32	6.32	6.23	6.23	NA			
5 GHz	6.48	6.48	6.40	6.40	6.32	NA			

2 mV/div, 25	2 mV/div, 25 GS/s, Sample Mode, 50 Ohm									
Frequency										
Bandwidth	10 MHz	250 MHz	1 GHz	2 GHz	4 GHz	7 GHz				
8 GHz	4.75	4.75	4.75	4.75	4.75	4.75				
7 GHz	4.95	4.95	4.95	4.95	4.95	4.95				
6 GHz	5.15	5.15	5.15	5.15	5.15	NA				
5 GHz	5.30	5.30	5.30	5.30	5.30	NA				

50 mV/div, 12.	5 GS/s, HiRes I	Mode, 50 Ohm			
Frequency					
Bandwidth	10 MHz	250 MHz	1 GHz	2 GHz	4 GHz
4 GHz	6.90	6.90	6.90	6.65	6.45
3 GHz	7.15	7.15	7.15	7.00	NA
2.5 GHz	7.25	7.25	7.25	7.05	NA
2 GHz	7.45	7.45	7.30	7.15	NA
1 GHz	7.85	7.85	7.65	NA	NA
500 MHz	8.15	8.15	NA	NA	NA
350 MHz	8.45	8.55	NA	NA	NA
250 MHz	8.55	8.65	NA	NA	NA
200 MHz	8.65	NA	NA	NA	NA
20 MHz	8.90	NA	NA	NA	NA

2 mV/div, 12.5	GS/s, HiRes M	ode, 50 Ohm			
Frequency					
Bandwidth	10 MHz	250 MHz	1 GHz	2 GHz	4 GHz
4 GHz	5.55	5.55	5.55	5.50	5.45
3 GHz	5.75	5.75	5.75	5.75	NA
2.5 GHz	5.85	5.85	5.85	5.85	NA
2 GHz	6.00	6.00	6.00	6.00	NA
1 GHz	6.45	6.45	6.45	NA	NA
500 MHz	6.85	6.85	NA	NA	NA
350 MHz	7.05	7.05	NA	NA	NA
250 MHz	7.15	7.15	NA	NA	NA
200 MHz	7.40	NA	NA	NA	NA
20 MHz	8.45	NA	NA	NA	NA

Random noise, sample acquisition mode

**√** 50 Ω

Table 1: 25 GS/s, Sample Mode, RMS

V/div	1 mV/div	2 mV/div	5 mV/div	10 mV/div	20 mV/div	50 mV/div	100 mV/div	1 V/div
8 GHz	223 μV	224 μV	293 μV	482 µV	890 μV	2.1 mV	4.88 mV	42 mV
7 GHz	199 μV	202 μV	271 μV	440 µV	793 μV	1.85 mV	4.4 mV	37 mV
6 GHz	179 µV	180 μV	233 μV	388 μV	691 µV	1.67 mV	3.83 mV	33.4 mV
5 GHz	158 µV	160 μV	210 µV	338 μV	630 µV	1.49 mV	3.42 mV	29.7 mV

Table 2: 12.5 GS/s, HiRes Mode, RMS

V/div	1 mV/div	2 mV/div	5 mV/div	10 mV/div	20 mV/div	50 mV/div	100 mV/div	1 V/div
4 GHz	138 µV	139 µV	175 µV	271 μV	486 μV	1.15 mV	2.71 mV	23.1 mV
3 GHz	117 µV	119 µV	149 µV	226 µV	398 μV	960 μV	2.28 mV	19.2 mV
2.5 GHz	108 μV	110 µV	133 µV	203 μV	363 µV	856 µV	2.03 mV	17.1 mV
2 GHz	96.3 µV	97.6 μV	118 µV	186 μV	320 µV	745 µV	1.81 mV	14.9 mV
1 GHz	77.3 µV	72.4 µV	89.6 µV	128 µV	226 µV	534 μV	1.33 mV	10.8 mV
500 MHz	56 μV	56.2 μV	68 µV	91.9 µV	162 µV	396 μV	941 µV	7.92 mV
350 MHz	47.7 μV	47.3 μV	56.5 µV	77.3 μV	133 µV	307 μV	792 µV	6.14 mV
250 MHz	46.1 µV	46.7 µV	54 μV	74.7 µV	120 µV	280 μV	722 µV	5.6 mV
200 MHz	37.9 μV	38 μV	44.4 µV	65.8 µV	106 μV	247 μV	666 µV	4.94 mV
20 MHz	13 µV	13.3 µV	15.6 µV	22.6 µV	41.2 µV	105 μV	236 μV	2.11 mV

50 Ω, typical

Table 3: 25 GS/s, Sample Mode, RMS

V/div	1 mV/div	2 mV/div	5 mV/div	10 mV/div	20 mV/div	50 mV/div	100 mV/div	1 V/div
8 GHz	158 µV	158 µV	208 μV	342 µV	630 µV	1.49 mV	3.46 mV	29.7 mV
7 GHz	141 µV	143 µV	192 µV	311 µV	562 μV	1.31 mV	3.11 mV	26.2 mV
6 GHz	127 µV	127 µV	165 µV	274 μV	489 μV	1.18 mV	2.71 mV	23.6 mV
5 GHz	112 µV	113 µV	149 µV	239 μV	446 μV	1.05 mV	2.42 mV	21.1 mV

Table 4: 12.5 GS/s, HiRes Mode, RMS

V/div	1 mV/div	2 mV/div	5 mV/div	10 mV/div	20 mV/div	50 mV/div	100 mV/div	1 V/div
4 GHz	97.4 μV	98.7 μV	124 µV	192 µV	344 μV	817 µV	1.92 mV	16.3 mV
3 GHz	82.9 µV	84 μV	105 μV	160 µV	282 μV	680 µV	1.62 mV	13.6 mV
2.5 GHz	76.5 µV	77.5 µV	93.8 µV	144 µV	257 μV	606 µV	1.44 mV	12.1 mV
2 GHz	68.1 μV	69.1 µV	83.6 µV	131 µV	226 μV	528 µV	1.28 mV	10.6 mV
Table continued		•	•	•	'	•	•	•

18

1 GHz	54.8 µV	51.2 μV	63.4 µV	90.9 µV	160 μV	378 μV	941 µV	7.65 mV
500 MHz	39.7 µV	39.8 µV	48.1 µV	65.1 µV	115 µV	280 μV	666 µV	5.6 mV
350 MHz	33.8 µV	33.5 µV	40 μV	54.8 µV	94.3 µV	217 µV	560 μV	4.35 mV
250 MHz	30.8 µV	31.2 µV	36.1 µV	49.9 µV	80.3 µV	187 μV	482 μV	3.75 mV
200 MHz	25.3 µV	25.4 µV	29.7 μV	44 µV	70.7 μV	165 µV	445 µV	3.3 mV
20 MHz	8.68 µV	8.9 µV	10.4 μV	15.1 µV	27.5 μV	70.4 μV	158 μV	1.41 mV

# $\checkmark$ High offset AC RMS Noise 50 Ω

Table 5: 25 GS/s, Sample Mode, RMS

V/div	1 mV/div	2 mV/div	5 mV/div	10 mV/div	20 mV/div	50 mV/div	100 mV/div	1 V/div
8 GHz	223 μV	224 μV	293 μV	482 µV	890 μV	2.1 mV	4.88 mV	42 mV
7 GHz	199 μV	202 μV	271 μV	440 µV	793 µV	1.85 mV	4.4 mV	37 mV
6 GHz	179 µV	180 μV	233 μV	388 µV	691 µV	1.67 mV	3.83 mV	33.4 mV
5 GHz	162 µV	164 μV	210 μV	338 μV	630 µV	1.49 mV	3.42 mV	29.7 mV

Table 6: 12.5 GS/s, HiRes Mode, RMS

V/div	1 mV/div	2 mV/div	5 mV/div	10 mV/div	20 mV/div	50 mV/div	100 mV/div	1 V/div
4 GHz	138 µV	139 μV	175 µV	271 µV	486 μV	1.15 mV	2.71 mV	23.1 mV
3 GHz	117 µV	119 µV	149 µV	226 µV	475 μV	975 μV	2.28 mV	21.4 mV
2 GHz	96.3 µV	97.6 μV	118 µV	212 µV	450 μV	920 µV	2.10 mV	21.0 mV
1 GHz	77.3 µV	72.4 µV	110 µV	190 μV	425 μV	900 μV	1.78 mV	19.2 mV
500 MHz	56 μV	56.2 μV	100 μV	182 μV	400 μV	840 μV	1.74 mV	16.8 mV
350 MHz	47.7 μV	47.3 μV	92.0 µV	165 µV	385 µV	770 μV	1.70 mV	16.1 mV
250 MHz	46.1 µV	46.7 µV	90.0 µV	145 µV	325 µV	675 µV	1.50 mV	15.8 mV
200 MHz	37.9 μV	38.0 µV	80.0 µV	120 µV	320 µV	660 µV	1.45 mV	15.2 mV
20 MHz	25.0 μV	25.0 μV	75.0 μV	115 µV	310 μV	560 μV	1.40 mV	13.0 mV

 $1\,\text{M}\Omega$  falls under the random noise specification at high offset levels.

Crosstalk (channel isolation), typical

≥80 dB up to 2 GHz

≥65 dB up to 5 GHz

≥55 dB up to 8 GHz

for any two channels set to 200 mV/div.

Overdrive recovery time, typical

#### 500 ns pulse width:

50Ω	400% Overdrive			2000% Overdrive		
Vertical scale	5%	1%	0.2%	5%	1%	0.2%
2 mV / div	< 50 ns	50 ns	300 ns	-	-	-
10 mV / div	< 50 ns	50 ns	300 ns	50 ns	50 ns	400 ns
0.1 V / div	< 50 ns	50 ns	300 ns	-	-	-

#### 100 us pulse width

50Ω	400% Overdrive			2000% Overdrive		
Vertical scale	5%	1%	0.2%	5%	1%	0.2%
2 mV / div	< 50 ns	50 ns	1 µs	-	-	-
10 mV / div	< 50 ns	50 ns	1 µs	< 50 ns	50 ns	150 µs
0.1 V / div	< 50 ns	50 ns	1 µs	-	-	-

#### SFDR analog channels, typical

SFDR, Single Tone							
Bandwidth	50 mV/div	2 mV/div					
8 GHz	-45 dB	-42 dB					
4 GHz/High Res	-51 dB	-51 dB					
2 GHz/High Res	-56 dB	-56 dB					

Delay between analog channels, full bandwidth, typical

≤ 10 ps for any two channels with equal Volts/div or above 10 mV/div

Deskew range

- -125 ns to +125 ns with a resolution of 40 ps (for Peak Detect and Envelope acquisition modes).
- -125 ns to +125 ns with a resolution of 1 ps (for all other acquisition modes).

# Timebase system

✓ Timebase accuracy

 $\pm 1.0 \text{ x} 10^{-7}$  over any  $\geq 1 \text{ ms time interval}$ 

Description	Specification
Factory Tolerance	±12 ppb
	At calibration, 25 °C ambient, over any ≥1 ms interval
Temperature stability	±20 ppb across the full operating range of 0 °C to 50 °C, after a sufficient soak time at the temperature
	Tested at operating temperatures
Table continued	

Description	Specification
Crystal aging	±300 PPB/Year and will not exceed ±2 PPM over 10 years without calibration.
	Calibration will reduce this frequency error to under ±12 PPB
	Frequency tolerance change at 25 °C over periods of 1 year and 10 years.

#### Sample rate range

Model	Number of channels in use	Maximum hardware capability
LPD64	4	6.25 S/s to 25 GS/s on all
		channels (real time)

Interpolated waveform rate range

2.5 TS/sec, 1 TS/sec, 500 GS/sec, 250 GS/sec, 100 GS/sec, 50 GS/sec, and 25 GS/sec (Interpolated HIRes)

Record length range

All acquisition modes are 250 M maximum record length, down to 1 k minimum record length, adjustable in 1 sample increments.

Standard: 125 Mpoints
Option 6-RL-2: 250 Mpoints

Seconds/Division range

Model	1 K	10 K	100 K	1 M	10 M	62.5 M	125 M	250 M	500 M	1 G
Standard 62.5 M	40 ps - 16 s	400 ps - 160 s	4 ns -	1000	S	2.5 µs - 1000 s	N/A	N/A	N/A	N/A
Option 6- RL-1 125 M	40 ps - 16 s	400 ps - 160 s	4 ns -	1000	S	2.5 µs - 1000 s	5 μs - 1000 s	N/A	N/A	N/A
Option 6- RL-2 250 M	40 ps - 16 s	400 ps - 160 s	4 ps -	1000	S	2.5 µs - 1000 s	5 μs - 1000 s	10 μs - 1000 s	N/A	N/A
Option 6- RL-3 500 Mpts	40 ps - 16 s	400 ps - 160 s	4 ps -	1000	S	2.5 us - 1000 s	5 us - 1000 s	10 us - 1000 s	20 us - 1000 s	N/A
Option 6- RL-4: 1 Gpts	40 ps - 16 s	400 ps - 160 s	4 ps -	1000	S	2.5 us - 1000 s	5 us - 1000 s	10 us - 1000 s	20 us - 1000 s	40 us - 1000 s

Aperture uncertainty (sample jitter)

Time duration	Typical jitter
<1 µs	80 fs
<1 ms	130 fs

Delta-time measurement accuracy, nominal

The formulas to calculate the peak-to-peak or rms nominal delta-time measurement accuracy (DTA) for a given instrument setting and input signal is as follows (assumes insignificant signal content above Nyquist frequency):

$$DTA_{RMS} = \sqrt{\left(\frac{N}{SR_1}\right)^2 + \left(\frac{N}{SR_2}\right)^2 + t_j^2} + TBA \times t_p$$

Where:

N = RSS of input-referred noise ( $V_{RMS}$ ) and dynamic noise estimate ( $V_{RMS}$ )

SR<sub>1</sub> = Slew Rate (1<sup>st</sup> Edge) around 1<sup>st</sup> point in measurement

SR<sub>2</sub> = Slew Rate (2<sup>nd</sup> Edge) around 2<sup>nd</sup> point in measurement

Dynamic noise is noise that appears with a signal applied (such as distortion or interleave errors).

Dynamic noise estimate =

Dynamic noise estimate\* = 
$$\sqrt{\frac{BW}{8 \text{ GHz}}} X 19.9 X 10^{-3} X \text{ volts/div}$$

Tj = aperture uncertainty (sec rms - 80 fs for short durations)

t<sub>p</sub> = delta-time measurement duration (sec)

TBA = timebase accuracy or Reference Frequency Error (which is 20 ppb)

(Assumes insignificant error due to aliasing or over-drive.)

The term under the square root sign is the stability and is due to TIE (Time Interval Error). The errors due to this term occur throughout a single-shot measurement. The second term is due to both the absolute center-frequency accuracy and the center-frequency stability of the timebase and varies between multiple single-shot measurements over the observation interval (the amount of time from the first single-shot measurement to the final single-shot measurement).



Note: The formulas assume negligible errors due to measurement interpolation, and apply only when the interpolated sample rate is 25 GS/s or higher.

### **Trigger system**

Trigger bandwidth (edge, pulse and logic), typical

Model	Trigger type	Trigger bandwidth
LPD64 8 GHz	Edge	8 GHz
LPD64 8 GHz	Pulse, Logic	4 GHz
LPD64 6 GHz	Edge	6 GHz
LPD64 6 GHz	Pulse, Logic	4 GHz
LPD64 4 GHz, 2.5 GHz, 1 GHz:	Edge, Pulse, Logic	Product Bandwidth

rate, typical

Maximum triggered acquisition Analog channels: single channel [Analog or Digital 8-bit channel] on screen, measurements and math turned off. >40 wfm/sec

FastAcq Update Rate (analog only, peak detect or envelope mode): >460 K/second with one channel active and >100 K/second with all active.

FastAcq Update Rate (All other acquisition Modes, one analog channel): 18 k/second .

Fast Frame Rate (50-point frames): 664 K/second

AUX Trigger skew between instruments, typical

 $\pm 100$  ps jitter on each instrument with up to 1.5 ns skew;  $\leq 1.5$  ns total between instruments.

Edge-type trigger sensitivity, DC coupled, typical

Path	Range	Specification
50 Ω path,	1 mV/div to 9.98 mV/div	3.0 div from DC to instrument bandwidth
	≥ 10 mV/div	< 1.0 division from DC to instrument bandwidth
Line	90 V to 264 V line voltage at 50 - 60 Hz line frequency	103.5 V to 126.5 V
AUX Trigger in		250 mVPP, DC to 400 MHz

#### Trigger jitter, typical

- ≤ 1.5 ps<sub>RMS</sub> for sample mode and edge-type trigger
- ≤ 2 ps<sub>RMS</sub> for edge-type trigger and FastAcq mode
- ≤ 40 ps<sub>RMS</sub> for non edge-type trigger modes
- ≤ 40 ps<sub>RMS</sub> for AUX trigger in, Sample acquisition mode, edge trigger
- ≤ 40 ps<sub>RMS</sub> for AUX trigger in, FastAcq acquisition mode, edge trigger

Lowest frequency for successful operation of Set Level to 50% function, typical 45 Hz

Pulse-type runt trigger sensitivities, typical

typical

2.0 division at vertical settings ≥5 mV/div.

Pulse-type trigger width and

2.0 divisions at vertical settings ≥5 mV/div.

glitch sensitivities, typical Logic-type, logic qualified trigger, or events-delay sensitivities, DC coupled,

2.0 divisions, at vertical settings  $\geq$ 5 mV/div.

Logic-type triggering, minimum logic or rearm time, typical

Triggering type	Pulse width		Time skew needed for 100% and no triggering
Logic	40 ps + t <sub>rise</sub>	40 ps + t <sub>rise</sub>	>360 ps / <150 ps
Time qualified logic	80 ps + t <sub>rise</sub>	80 ps + t <sub>rise</sub>	>360 ps / <150 ps

t<sub>rise</sub> is rise time of the instrument.

For Logic, time between channels refers to the length of time a logic state derived from more than one channel must exist to be recognized. For Events, the time is the minimum time between a main and delayed event that will be recognized if more than one channel is used.

Minimum clock pulse widths for setup/hold time violation trigger, typical

Minimum pulse width, clock active	Minimum pulse width, clock inactive
80 ps + t <sub>rise</sub>	80 ps + t <sub>rise</sub>

t<sub>rise</sub> is rise time of the instrument.

Setup + Hold must be less than the clock period.

Active pulse width is the width of the clock pulse from its active edge (as defined in the Clock Edge menu item) to its inactive edge.

Inactive pulse width is the width of the pulse from its inactive edge to its active edge.

Setup/hold violation trigger, setup and hold time ranges, typical

Feature	Min	Max
Setup Time	0 ns	20 s
Hold Time	0 ns	20 s
Setup + Hold Time	80 ps	22 s

Input coupling on clock and data channels must be the same.

For Setup Time, positive numbers mean a data transition before the clock.

For Hold Time, positive numbers mean a data transition after the clock edge.

Setup + Hold Time is the algebraic sum of the Setup Time and the Hold Time programmed by the user.

Pulse type trigger, minimum pulse, rearm time, transition time

Pulse class	Minimum pulse width	Minimum rearm time
Runt	40 ps + t <sub>rise</sub>	40 ps + t <sub>rise</sub>
Time-Qualified Runt	40 ps + t <sub>rise</sub>	40 ps + t <sub>rise</sub>
Width	40 ps + t <sub>rise</sub>	40 ps + t <sub>rise</sub>

Trigger class	Minimum transition time	Minimum rearm time
Rise/Fall Time	40 ps + t <sub>rise</sub>	40 ps + t <sub>rise</sub>

For trigger class width, pulse width refers to the width of the pulse being measured. Rearm time refers to the time between pulses.

For trigger class runt, pulse width refers to the width of the pulse being measured. Rearm time refers to the time between pulses.

 $t_{\text{rise}}$  is rise time of the instrument.

Time range for glitch, pulse width, timeout, time-qualified runt, or time-qualified window triggering

40 ps to 20 s.

Time accuracy for pulse width and timeout triggering

Time Range	Accuracy
320 ps to 20 s	±(40 ps +Time Base Error * Setting).

B trigger after events, minimum pulse width and maximum event frequency, typical

Minimum pulse width: 40 ps + t<sub>rise</sub>

Maximum event frequency: Instrument bandwidth.

t<sub>rise</sub> is rise time of the instrument.

B trigger, minimum time between arm and trigger, typical

80 ps

For trigger after time, this is the time between the end of the time period and the B trigger event. For trigger after events, this is the time between the last A trigger event and the first B trigger event.

B trigger after time, time range 40 ps to 20 seconds

Accuracy = ± (40ps + (Time-Base-Error \* Setting))

B trigger after events, event range

1 to 65,471

**Trigger level ranges** 

Source	Range
Any Channel	±5 divs from center of screen
Aux In Trigger	±5 V
Line	Fixed at about 50% of line voltage

This specification applies to logic and pulse thresholds.

Trigger level accuracy, DC coupled, typical

For signals having rise and fall times ≥10 ns:

Source	Range
Any Input Channel	±0.20 div
Line	N/A

Trigger holdoff range 0 ns to 10 seconds

### **Serial Trigger specifications**

Maximum serial trigger bits 128 bits

Optional serial bus interface triggering

Please refer to the Serial Triggering and Analysis 3 Series MDO, 4/5/6 Series MSO Applications Datasheet (part number 61W-61101-x), located on tek.com, for information on available serial triggering options and

their triggering capabilities.

### Digital volt meter (DVM)

Measurement types DC, AC<sub>RMS</sub>+DC, AC<sub>RMS</sub>, Trigger frequency count

Voltage resolution 4 digits

✓ Voltage accuracy

**DC:**  $\pm ((1.5\% * | reading - offset - position|) + (0.5\% * | (offset - position)|) + (0.1 * Volts/div))$ 

De-rated at 0.100%/°C of |reading - offset - position| above 30 °C

Signal ± 5 divisions from screen center

AC: ± 3% (40 Hz to 1 kHz) with no harmonic content outside 40 Hz to 1 kHz

AC, typical:  $\pm$  2% (20 Hz to 10 kHz)

For AC measurements, the input channel vertical settings must allow the VPP input signal to cover between 4

and 10 divisions and must be fully visible on the screen

### **Trigger frequency counter**

**Resolution** 8-digits

✓ Accuracy ±(1 count + time base accuracy \* input frequency)

The signal must be at least 8 mV<sub>pp</sub> or 2 div, whichever is greater.

**Trigger frequency counter** 

source

Any analog input channel.

✓ Maximum input frequency 10 Hz to maximum bandwidth of the analog channel

The signal must be at least 8 mV<sub>pp</sub> or 2 div, whichever is greater.

### **Arbitrary function generator**

Function types Arbitrary, sine, square, pulse, ramp, triangle, DC level, Gaussian, Lorentz, exponential rise/fall, sin(x)/x,

random noise, Haversine, Cardiac

Amplitude range Values are peak-to-peak voltages

Waveform	50 Ω	1 ΜΩ
Arbitrary	10 mV to 2.5 V	20 mV to 5 V
Sine	10 mV to 2.5 V	20 mV to 5 V
Square	10 mV to 2.5 V	20 mV to 5 V
Pulse	10 mV to 2.5 V	20 mV to 5 V
Ramp	10 mV to 2.5 V	20 mV to 5 V
Triangle	10 mV to 2.5 V	20 mV to 5 V
Table continued		

Waveform	50 Ω	1 ΜΩ
Gaussian	10 mV to 1.25 V	20 mV to 2.5 V
Lorentz	10 mV to 1.2 V	20 mV to 2.4 V
Exponential Rise	10 mV to 1.25 V	20 mV to 2.5 V
Exponential Fall	10 mV to 1.25 V	20 mV to 2.5 V
Sine(x)/x	10 mV to 1.5 V	20 mV to 3.0 V
Random Noise	10 mV to 2.5 V	20 mV to 5 V
Haversine	10 mV to 1.25 V	20 mV to 2.5 V
Cardiac	10 mV to 2.5 V	20 mV to 5 V

**Arbitrary function record** 

length

128 K Samples

Maximum sample rate 250 MS/s

Sine waveform

Frequency range 0.1 Hz to 50 MHz

Frequency setting

resolution

0.1 Hz

Frequency accuracy 130 ppm (frequency ≤ 10 kHz), 50 ppm (frequency > 10 kHz)

This is for Sine, Ramp, Square and Pulse waveforms only.

Amplitude range 20 mV  $_{pp}$  to 5 V  $_{pp}$  into Hi-Z; 10 mV  $_{pp}$  to 2.5 V  $_{pp}$  into 50  $\Omega$ 

Amplitude flatness, typical ±0.5 dB at 1 kHz

±1.5 dB at 1 kHz for < 20 mV<sub>pp</sub> amplitudes

Total harmonic distortion,

typical

1% for amplitude ≥ 200 mV<sub>pp</sub> into 50  $\Omega$  load

2.5% for amplitude > 50 mV AND < 200 mV  $_{\text{DD}}$  into 50  $\Omega$  load

This is for Sine wave only.

Spurious free dynamic

range, typical

40 dB ( $V_{pp} ≥ 0.1 V$ ); 30 dB ( $V_{pp} ≥ 0.02 V$ ), 50 Ω load

Square and pulse waveform

Frequency range 0.1 Hz to 25 MHz

Frequency setting

resolution

0.1 Hz

**Duty cycle range** 10% - 90% or 10 ns minimum pulse, whichever is larger

Minimum pulse time applies to both on and off time, so maximum duty cycle will reduce at higher frequencies

to maintain 10 ns off time

Duty cycle resolution 0.1%

Minimum pulse width,

typical

10 ns. This is the minimum time for either on or off duration.

Rise/Fall time, typical

5 ns, 10% - 90%

Pulse width resolution

100 ps

Overshoot, typical

< 6% for signal steps greater than 100 mV<sub>pp</sub>

This applies to overshoot of the positive-going transition (+overshoot) and of the negative-going (-overshoot)

transition

Asymmetry, typical

±1% ±5 ns, at 50% duty cycle

Jitter, typical

< 60 ps  $TIE_{RMS}$ ,  $\geq$  100 mV<sub>pp</sub> amplitude, 40%-60% duty cycle

Square and pulse waveforms, 5 GHz measurement BW.

Ramp and triangle waveform

Frequency range

0.1 Hz to 500 kHz

Frequency setting

resolution

0.1 Hz

Variable symmetry 0% - 100%

Symmetry resolution

0.1%

DC level range

±2.5 V into Hi-Z

 $\pm 1.25$  V into 50  $\Omega$ 

Gaussian pulse, Haversine, and Lorentz pulse

Maximum frequency

5 MHz

Exponential rise fall maximum 5 MHz

frequency

Sin(x)/x

Maximum frequency

2 MHz

Random noise amplitude

range

20 mV $_{DD}$  to 5 V $_{DD}$  into Hi-Z

10 mV  $_{pp}$  to 2.5 V  $_{pp}$  into 50  $\Omega$ 

For both isolated noise signal and additive noise signal.

✓ Sine and ramp frequency

accuracy

130 ppm (frequency ≤10 kHz)

50 ppm (frequency >10 kHz)

✓ Square and pulse

130 ppm (frequency ≤10 KHz);

frequency accuracy

50 ppm (frequency >10 KHz)

Signal amplitude resolution

1 mV (Hi-Z)

500 μV (50 Ω)

✓ Signal amplitude accuracy ±[ (1.5% of peak-to-peak amplitude setting) + (1.5% of absolute DC offset setting) + 1 mV ] (frequency = 1

kHz)

**DC offset range** ±2.5 V into Hi-Z

 $\pm 1.25$  V into 50  $\Omega$ 

**DC offset resolution** 1 mV (Hi-Z)

 $500 \mu V (50 Ω)$ 

✓ DC offset accuracy ±[ (1.5% of absolute offset voltage setting) + 1 mV ]

Add 3 mV of uncertainty per 10 °C change from 25 °C ambient

Cardiac maximum frequency 500 kHz

### **Processor system**

Host processor Intel i5-4400E, 2.7 GHz, 64-bit, dual core processor, 8 GB system RAM

### Input/Output port specifications

Ethernet interface An 8-pin RJ-45 connector that supports 10/100/1000 Mb/s

Video signal output A 29-pin HDMI connector

Recommended resolution: 1920 x 1080 @ 60 Hz. Note that video out may not be hot pluggable. HDMI cable may need to be attached before power up for dual display functions to work depending upon the

instrument firmware revision

**DVI connector** A 29-pin DVI-I connector; connect to show the oscilloscope display on an external monitor or projector

Maximum supported resolution, Windows: 1920 x 1200 at 60 Hz Maximum supported resolution, Linux: 1920 x 1080 at 60 Hz

Only a single TMDS link is provided Analog VGA signaling is not provided

**VGA connector** A 15-pin, 3-row, D-sub VGA connector

Recommended resolution: 1920 x 1080 at 60 Hz

**DisplayPort connector** A 20-pin DisplayPort connector; connect to show the oscilloscope display on an external monitor or

projector Maximum supported resolution, Windows: 2560 x 1440 @ 60Hz

Maximum supported resolution, Linux: 1920 x 1080 @ 60 Hz

DP++ adapter: Maximum supported resolution: 2560 x1440 @ 60 Hz

**Simultaneous displays** Up to 3 displays with a maximum of 1 display per port.

USB interface (Host, Device

ports)

Front panel USB Host ports: Two USB 2.0 Hi-Speed ports, one USB 3.0 SuperSpeed port

All instruments, Rear panel USB Host ports: Two USB 2.0 Hi-Speed ports, two USB 3.0 SuperSpeed ports All instruments, Rear panel USB Device port: One USB 3.0 SuperSpeed Device port providing USBTMC

support

#### Auxiliary output, AUX OUT, Trigger Out, Event, or Reference Clock Out

Selectable output Acquisition Trigger Out

Reference Clock Out AFG Trigger Out

**Acquisition Trigger Out** 

User selectable transition from HIGH to LOW, or LOW to HIGH, indicates the trigger occurred. The signal

returns to its previous state after approximately 100 ns

Acquisition trigger jitter

< 50ps standard deviation

Reference Clock Out

Reference clock output tracks the acquisition system and can be referenced from either the internal clock

reference or the external clock reference

**AFG Trigger Out** 

The output frequency is dependent on the frequency of the AFG signal as shown in the following table:

AFG signal frequency	AFT trigger frequency
≤ 4.9 MHz	Signal frequency
> 4.9 MHz to 14.7 MHz	Signal frequency / 3
> 14.7 MHz to 24.5 MHz	Signal frequency / 5
> 24.5 MHz to 34.3 MHz	Signal frequency / 7
> 34.3 MHz to 44.1 MHz	Signal frequency / 9
> 44.1 MHz to 50 MHz	Signal frequency / 11

#### **AUX OUT Output Voltage**

Characteristic	Limits
Vout (HI)	≥ 2.5 V open circuit; ≥ 1.0 V into a 50 Ω load to ground
Vout (LO)	≤ 0.7 V into a load of ≤ 4 mA; ≤0.25 V into a 50 Ω load to ground

#### **External reference input**

Nominal input frequency 10 MHz

Frequency Variation

**Tolerance** 

9.99999 MHz to 10.00001 MHz (±1.0 x 10<sup>-6</sup>)

Sensitivity, typical  $V_{in}$  1.5  $V_{p-p}$  using a 50  $\Omega$  termination

Maximum input signal  $7 V_{pp}$ 

745 Ohms ±20% in parallel with 18.5 pf ±20% **Impedance** 

**AUX trigger input** 

Interface: SMA 50 O Input Impedance: **Maximum Input Voltage:** 5 V<sub>RMS</sub>

Sensitivity: Edge-type trigger sensitivity, DC-coupled

### Data storage specifications

time, typical

**Nonvolatile memory retention** No time limit for front panel settings, saved waveforms, setups, product licensing, and calibration constants.

Real-time clock

A programmable clock providing time in years, months, days, hours, minutes, and seconds.

Nonvolatile memory capacity

Instrument S/N A 2 kbit EEPROM on the main board that stores the instrument serial number, instrument start up count, total

uptime and administration passwords.

Companion CvP A pair of 16 Mbit flash memory devices that stores a portion of the Companion FPGA image data. One device

serves as a backup for the other device.

AFG S/N A 2 kbit EEPROM on the AFG riser card that stores a copy of the instrument serial number which is used to

validate the AFG calibration.

**Front Panel ID** A 4GB EMMC flash memory that stores calibration data and licensing information.

**BIOS** A 128 Mbit flash memory device that stores the firmware image and device configuration for the host processor

> and chipset sub-processors. This includes the Basic Input Output System (BIOS), Management Engine (ME), Embedded Controller (EC) and Network Interface Controller (NIC). The Ethernet MAC address is stored in this

device.

**CMOS Memory** The host processor chipset includes an integrated memory device, powered by the real-time clock (RTC)

battery, which stores BIOS configuration settings. A customer accessible switch disconnects the RTC battery

from the chipset which clears the contents of the integrated CMOS memory device.

**Memory SPD** Each SODIMM (memory module) contains a serial presence detect (SPD) memory device implemented using

> an unspecified memory technology. Each SPD device contains the parameter data specific to its memory module. All SPD devices are treated by the instrument as read only. The size of a given SPD is unspecified.

The 4 channel instrument includes 4 SPD devices.

UCD9248 The instrument includes 3 UCD9248 power supply controllers. Each controller contains an unspecified quantity

of nonvolatile memory that stores various power supply configuration settings.

**PMU** A power management unit (PMU) microcontroller is used to manage instrument power supplies and hardware

initialization. The PMU includes 32 KB of nonvolatile memory for storage of its own binary executable and

redundant storage of UCD9248 device settings.

**Analog Board Controller** A microcontroller is used to manage analog board operation. The PMU includes 64 KB of nonvolatile memory

for storage of its own binary executable.

**Carrier FPGA** The carrier FPGA stores its own configuration in its own internal 0.33 Mbit nonvolatile memory. The carrier

FPGA implements simple "glue logic" for the instrument.

#### Mass storage device capacity

**Linux/Windows (optional):** ≥80 GB. Form factor is an 80 mm m.2 card with a SATA-3 interface. Waveforms and setups are stored on a

hard disk drive or solid state drive. Provides storage for saved customer data and the Linux operating system. This drive is customer installable. A ~42 GB partition on the device is available for the storage of saved

customer data.

### Power supply system

Power

Power consumption 400 Watts maximum

**Source voltage** 100 - 240 V ±10% (50 Hz to 60 Hz)

Source frequency 50 Hz to 60 Hz  $\pm$ 10%, at 100 - 240 V  $\pm$ 10%

400 Hz at 115 V ±10%

Fuse Rating 12.5 A, 250 V<sub>ac</sub>

### Safety characteristics

Safety certification US NRTL Listed - UL61010-1.

Canadian Certification - CAN/CSA-C22.2 No. 61010.1.

EU Compliance - Low Voltage Directive 2014-35-EU and EN61010-1.

International Compliance - IEC 61010-1.

**Pollution degree** Pollution degree 2, indoor, dry location use only

### **Environmental specifications**

**Temperature** 

Operating +0 °C to +50 °C (32 °F to 122 °F) Non-operating -20 °C to +60 °C (-4 °F to 140 °F)

Humidity

Operating 5% to 90% relative humidity (% RH) at up to +40 °C

5% to RH above +40 °C up to +50 °C, noncondensing

Non-operating 5% to 90% relative humidity (% RH) at up to +60 °C, noncondensing

**Altitude** 

**Operating** Up to 3,000 meters (9,843 feet)

Non-operating Up to 12,000 meters (39,370 feet)

### **Mechanical specifications**

**Weight** LPD64 29.4 lbs (13.34 kg)

**Dimensions** Height: 87.8 mm (3.5 in) from bottom to top cover. With bench conversion kit feet 107.8 mm (4.25 in)

Width: 432.1 mm (17.0 in) from cover edge to cover edge

Depth: 613.4 mm (23.9 in) from back of cover to front bezel. 624.7 mm (24.6 in) from rear IO BNCs to front

SMA connectors.

Cooling The clearance requirement for adequate cooling is 2.0 in (50.8 mm) to the left (intake) and right (exhaust)

side (when looking at the front of the instrument) of the instrument.

# **Performance verification procedures**

This chapter contains performance verification procedures for the specifications marked with the v symbol. The following equipment, or a suitable equivalent, is required to complete these procedures.

The performance verification procedures verify the performance of your instrument. They do not adjust your instrument. If your instrument fails any of the performance verification tests, repeat the failing test, verifying that the test equipment and settings are correct. If the instrument continues to fail a test, contact Tektronix Customer Support for assistance.

These procedures cover all LPD64 instruments. Completion of the performance verification procedure does not update the instrument time and date.

Print the test records on the following pages and use them to record the performance test results for your oscilloscope. Disregard checks and test records that do not apply to the specific model you are testing.

The following table lists the required equipment. You might need additional cables and adapters, depending on the actual test equipment you use.

Required equipment	Minimum requirements	Examples
DC voltage source	3 mV to 4 V, ±0.1% accuracy	Fluke 9500B Oscilloscope Calibrator with a 9530 Output Module
Leveled sine wave generator	50 kHz to 8 GHz, ±4% amplitude accuracy	
Time mark generator	80 ms period, $\pm 1.0 \times 10^{-6}$ accuracy, rise time <50 ns	
Digital multimeter (DMM)	0.1% accuracy or better	Tektronix DMM4020
One 50 Ω terminator	Impedance 50 Ω; connectors: female SMA input, male SMA output	
One 50 Ω SMA cable	Male-to-male connectors	
Optical mouse	USB, PS2	Tektronix part number 119-7054-00
RF vector signal generator	Maximum bandwidth of instrument	Tektronix TSG4100A
Frequency counter	parts per billion accuracy	Tektronix FCA3000 Timer/Counter/Analyzer

## **Test records**

### Instrument information, self test record

Model	Serial #	Procedure performed by	Date

Test	Passed	Failed
Self Test		

Input Impedance				
Performance checks	Vertical scale	Low limit	Test result	High limit
All models				
Channel 1 Input	10 mV/div	48.5 Ω		51.5 Ω
Impedance, 50 Ω	100 mV/div	48.5 Ω		51.5 Ω
Channel 2 Input	10 mV/div	48.5 Ω		51.5 Ω
Impedance, 50 Ω	100 mV/div	48.5 Ω		51.5 Ω
Channel 3 Input	10 mV/div	48.5 Ω		51.5 Ω
Impedance, 50 Ω	100 mV/div	48.5 Ω		51.5 Ω
Channel 4 Input Impedance, 50 Ω	10 mV/div	48.5 Ω		51.5 Ω
	100 mV/div	48.5 Ω		51.5 Ω

### DC Balance test record

DC Balance				
Performance checks	Vertical scale	Low limit	Test result	High limit
Channel 1 DC Balance,	1 mV/div	-0.2 mV		0.2 mV
50 Ω,20 MHz BW	2 mV/div	-0.2 mV		0.2 mV
	5 mV/div	-0.5 mV		0.5 mV
	10 mV/div	-1 mV		1 mV
	20 mV/div	-2 mV		2 mV
	49.8 mV/div	-4.98 mV		4.98 mV
	50 mV/div	-5 mV		5 mV
	100 mV/div	-10 mV		10 mV
500	200 mV/div	-20 mV		20 mV
	500 mV/div	-50 mV		50 mV
	1 V/div	-100 mV		100 mV
Channel 1 DC Balance, 50 Ω,250 MHz BW	20 mV/div	-2 mV		2 mV
able continued	1	·	1	1

DC Balance				
Performance checks	Vertical scale	Low limit	Test result	High limit
Channel 1 DC Balance, 50 Ω, Full BW	20 mV/div	-2 mV		2 mV
Channel 2 DC Balance, 50 Ω,20 MHz BW	1 mV/div	-0.2 mV		0.2 mV
	2 mV/div	-0.2 mV		0.2 mV
	5 mV/div	-0.5 mV		0.5 mV
	10 mV/div	-1 mV		1 mV
	20 mV/div	-2 mV		2 mV
	49.8 mV/div	-4.98 mV		4.98 mV
	50 mV/div	-5 mV		5 mV
	100 mV/div	-10 mV		10 mV
	200 mV/div	-20 mV		20 mV
	500 mV/div	-50 mV		50 mV
	1 V/div	-100 mV		100 mV
Channel 2 DC Balance, 50 Ω,250 MHz BW	20 mV/div	-2 mV		2 mV
Channel 2 DC Balance, 50 Ω, Full BW	20 mV/div	-2 mV		2 mV
Channel 3 DC Balance,	1 mV/div	-0.2 mV		0.2 mV
50 Ω,20 MHz BW	2 mV/div	-0.2 mV		0.2 mV
	5 mV/div	-0.5 mV		0.5 mV
	10 mV/div	-1 mV		1 mV
	20 mV/div	-2 mV		2 mV
	49.8 mV/div	-4.98 mV		4.98 mV
	50 mV/div	-5 mV		5 mV
	100 mV/div	-10 mV		10 mV
	200 mV/div	-20 mV		20 mV
	500 mV/div	-50 mV		50 mV
	1 V/div	-100 mV		100 mV
Channel 3 DC Balance, 50 Ω,250 MHz BW	20 mV/div	-2 mV		2 mV
Channel 3 DC Balance, 50 Ω, Full BW	20 mV/div	-2 mV		2 mV

DC Balance				
Performance checks	Vertical scale	Low limit	Test result	High limit
Channel 4 DC Balance,	1 mV/div	-0.2 mV		0.2 mV
50 Ω,20 MHz BW	2 mV/div	-0.2 mV		0.2 mV
	5 mV/div	-0.5 mV		0.5 mV
	10 mV/div	-1 mV		1 mV
	20 mV/div	-2 mV		2 mV
	49.8 mV/div	-4.98 mV		4.98 mV
	50 mV/div	-5 mV		5 mV
	100 mV/div	-10 mV		10 mV
	200 mV/div	-20 mV		20 mV
	500 mV/div	-50 mV		50 mV
	1 V/div	-100 mV		100 mV
Channel 4 DC Balance, 50 Ω,250 MHz BW	20 mV/div	-2 mV		2 mV
Channel 4 DC Balance, 50 Ω, Full BW	20 mV/div	-2 mV		2 mV

#### **DC Offset Accuracy test record**

Offset Accuracy					
Performance checks	Vertical scale	Vertical offset <sup>1</sup>	Low limit	Test result	High limit
Channel 1 DC Offset	1 mV/div	900 mV	895.3 mV		904.7 mV
Accuracy, 20 MHzBW, 50 Ω	1 mV/div	-900 mV	-904.7 mV		-895.3 mV
IVII 12DVV, 30 12	100 mV/div	5.0 V	4.965 V		5.035 V
	100 mV/div	-5.0 V	-5.035 V		-4.965 V
Channel 2 DC Offset	1 mV/div	900 mV	895.3 mV		904.7 mV
Accuracy, 20 MHzBW, 50 Ω	1 mV/div	-900 mV	-904.7 mV		-895.3 mV
IVII 12DVV, 30 12	100 mV/div	5.0 V	4.965 V		5.035 V
	100 mV/div	-5.0 V	-5.035 V		-4.965 V
Channel 3 DC Offset	1 mV/div	900 mV	895.3 mV		904.7 mV
Accuracy, 20 MHz BW, 50 Ω	1 mV/div	-900 mV	-904.7 mV		-895.3 mV
	100 mV/div	5.0 V	4.965 V		5.035 V
	100 mV/div	-5.0 V	-5.035 V		-4.965 V
Table continued		'	'	'	'

<sup>1</sup> Use this value for both the calibrator output and the oscilloscope offset setting.

Offset Accuracy	Offset Accuracy					
Performance checks	Vertical scale	Vertical offset <sup>1</sup>	Low limit	Test result	High limit	
Channel 4 DC Offset	1 mV/div	900 mV	895.3 mV		904.7 mV	
Accuracy, 20 MHz BW, 50 Ω	1 mV/div	-900 mV	-904.7 mV		-895.3 mV	
DVV, 30 12	100 mV/div	5.0 V	4.965 V		5.035 V	
	100 mV/div	-5.0 V	-5.035 V		-4.965 V	

## DC Gain Accuracy test record

DC Gain Accuracy	D. 1.110	V. C. I I	1	T ( 1(	10.1.0
Performance checks	Bandwidth	Vertical scale	Low limit	Test result	High limit
Channel 1 DC Gain	20 MHz	1 mV/div	-4%		4%
Accuracy, 0 V offset, 0 V vertical position,		2 mV/div	-2%		2%
50 $\Omega$		5 mV/div	-2%		2%
		10 mV/div	-2%		2%
		20 mV/div	-2%		2%
		50 mV/div	-2%		2%
		100 mV/div	-2%		2%
		200 mV/div	-2%		2%
		500 mV/div	-2%		2%
		1 V/div	-2%		2%
	250 MHz	20 mV/div	-2%		2%
	FULL	20 mV/div	-2%		2%
Channel 2 DC Gain	20 MHz	1 mV/div	-4%		4%
Accuracy, 0 V offset, 0 V vertical position,		2 mV/div	-2%		2%
50 $\Omega$		5 mV/div	-2%		2%
		10 mV/div	-2%		2%
		20 mV/div	-2%		2%
		50 mV/div	-2%		2%
		100 mV/div	-2%		2%
		200 mV/div	-2%		2%
		500 mV/div	-2%		2%
		1 V/div	-2%		2%
	250 MHz	20 mV/div	-2%		2%
	FULL	20 mV/div	-2%		2%

<sup>1</sup> Use this value for both the calibrator output and the oscilloscope offset setting.

Performance checks	Bandwidth	Vertical scale	Low limit	Test result	High limit
Channel 3 DC Gain	20 MHz	1 mV/div	-4%		4%
Accuracy, 0 V offset,		2 mV/div	-2%		2%
0 V vertical position, 50 $\Omega$		5 mV/div	-2%		2%
JU 12		10 mV/div	-2%		2%
		20 mV/div	-2%		2%
		50 mV/div	-2%		2%
		100 mV/div	-2%		2%
		200 mV/div	-2%		2%
		500 mV/div	-2%		2%
		1 V/div	-2%		2%
	250 MHz	20 mV/div	-2%		2%
	FULL	20 mV/div	-2%		2%
Channel 4 DC Gain	20 MHz	1 mV/div	-4%		4%
Accuracy, 0 V offset, 0 V vertical position,		2 mV/div	-2%		2%
50 $\Omega$		5 mV/div	-2%		2%
		10 mV/div	-2%		2%
		20 mV/div	-2%		2%
		50 mV/div	-2%		2%
		100 mV/div	-2%		2%
		200 mV/div	-2%		2%
		500 mV/div	-2%		2%
		1 V/div	-2%		2%
	250 MHz	20 mV/div	-2%		2%
	FULL	20 mV/div	-2%		2%

# Analog Bandwidth test record

Analog Bandw	idth						
Performance c	hecks						
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	V <sub>in-pp</sub>	V <sub>bw-pp</sub>	Limit	Test result Gain = V <sub>bw-pp</sub> / V <sub>in-pp</sub>
Channel 1	50 Ω	1 mV/div	1 ns/div			≥ 0.707	
		2 mV/div	1 ns/div			≥ 0.707	
		4 mV/div	1 ns/div			≥ 0.707	
		10 mV/div	1 ns/div			≥ 0.707	
		25 mV/div	1 ns/div			≥ 0.707	
		50 mV/div	1 ns/div			≥ 0.707	
		100 mV/div	1 ns/div			≥ 0.707	
Channel 2	50 Ω	1 mV/div	1 ns/div			≥ 0.707	
		2 mV/div	1 ns/div			≥ 0.707	
		4 mV/div	1 ns/div			≥ 0.707	
		10 mV/div	1 ns/div			≥ 0.707	
		25 mV/div	1 ns/div			≥ 0.707	
		50 mV/div	1 ns/div			≥ 0.707	
		100 mV/div	1 ns/div			≥ 0.707	
Channel 3	50 Ω	1 mV/div	1 ns/div			≥ 0.707	
		2 mV/div	1 ns/div			≥ 0.707	
		4 mV/div	1 ns/div			≥ 0.707	
		10 mV/div	1 ns/div			≥ 0.707	
		25 mV/div	1 ns/div			≥ 0.707	
		50 mV/div	1 ns/div			≥ 0.707	
		100 mV/div	1 ns/div			≥ 0.707	
Channel 4	50 Ω	1 mV/div	1 ns/div			≥ 0.707	
		2 mV/div	1 ns/div			≥ 0.707	
		4 mV/div	1 ns/div			≥ 0.707	
		10 mV/div	1 ns/div			≥ 0.707	
		25 mV/div	1 ns/div			≥ 0.707	
		50 mV/div	1 ns/div			≥ 0.707	
		100 mV/div	1 ns/div			≥ 0.707	

## Random Noise, sample acquisition mode test record

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth <sup>2</sup>	Test result (mV)	High limit (mV)
Channel 1	1 mV/div	8 GHz		0.223
		7 GHz limit		0.199
		6 GHz limit		0.179
		5 GHz limit		0.158
	2 mV/div	8 GHz		0.224
		7 GHz limit		0.202
		6 GHz limit		0.180
		5 GHz limit		0.160
	5 mV/div	8 GHz		0.293
		7 GHz limit		0.271
		6 GHz limit		0.233
		5 GHz limit		0.210
	10 mV/div	8 GHz		0.482
		7 GHz limit		0.440
		6 GHz limit		0.388
		5 GHz limit		0.338
	20 mV/div	8 GHz		0.890
		7 GHz limit		0.793
		6 GHz limit		0.691
		5 GHz limit		0.630
	50 mV/div	8 GHz		2.10
		7 GHz limit		1.85
		6 GHz limit		1.67
		5 GHz limit		1.49
	100 mV/div	8 GHz		4.88
		7 GHz limit		4.4
		6 GHz limit		3.83
		5 GHz limit		3.42
	1 V/div	8 GHz		42.0
		7 GHz limit		37.0
		6 GHz limit		33.4
		5 GHz limit		29.7

<sup>&</sup>lt;sup>2</sup> Start with the highest bandwidth setting you can select.

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth <sup>2</sup>	Test result (mV)	High limit (mV)
Channel 2	1 mV/div	8 GHz		0.223
		7 GHz limit		0.199
		6 GHz limit		0.179
		5 GHz limit		0.158
	2 mV/div	8 GHz		0.224
		7 GHz limit		0.202
		6 GHz limit		0.180
		5 GHz limit		0.160
	5 mV/div	8 GHz		0.293
		7 GHz limit		0.271
		6 GHz limit		0.233
		5 GHz limit		0.210
	10 mV/div	8 GHz		0.482
		7 GHz limit		0.440
		6 GHz limit		0.388
		5 GHz limit		0.338
	20 mV/div	8 GHz		0.890
		7 GHz limit		0.793
		6 GHz limit		0.691
		5 GHz limit		0.630
	50 mV/div	8 GHz		2.10
		7 GHz limit		1.85
		6 GHz limit		1.67
		5 GHz limit		1.49
	100 mV/div	8 GHz		4.88
		7 GHz limit		4.4
		6 GHz limit		3.83
		5 GHz limit		3.42
	1 V/div	8 GHz		42.0
		7 GHz limit		37.0
		6 GHz limit		33.4
		5 GHz limit		29.7

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth <sup>2</sup>	Test result (mV)	High limit (mV)
Channel 3	1 mV/div	8 GHz		0.223
		7 GHz limit		0.199
		6 GHz limit		0.179
		5 GHz limit		0.158
	2 mV/div	8 GHz		0.224
		7 GHz limit		0.202
		6 GHz limit		0.180
		5 GHz limit		0.160
	5 mV/div	8 GHz		0.293
		7 GHz limit		0.271
		6 GHz limit		0.233
		5 GHz limit		0.210
	10 mV/div	8 GHz		0.482
		7 GHz limit		0.440
		6 GHz limit		0.388
		5 GHz limit		0.338
	20 mV/div	8 GHz		0.890
		7 GHz limit		0.793
		6 GHz limit		0.691
		5 GHz limit		0.630
	50 mV/div	8 GHz		2.10
		7 GHz limit		1.85
		6 GHz limit		1.67
		5 GHz limit		1.49
	100 mV/div	8 GHz		4.88
		7 GHz limit		4.4
		6 GHz limit		3.83
		5 GHz limit		3.42
	1 V/div	8 GHz		42.0
		7 GHz limit		37.0
		6 GHz limit		33.4
		5 GHz limit		29.7

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth <sup>2</sup>	Test result (mV)	High limit (mV)
Channel 4	1 mV/div	8 GHz		0.223
		7 GHz limit		0.199
		6 GHz limit		0.179
		5 GHz limit		0.158
	2 mV/div	8 GHz		0.224
		7 GHz limit		0.202
		6 GHz limit		0.180
		5 GHz limit		0.160
	5 mV/div	8 GHz		0.293
		7 GHz limit		0.271
		6 GHz limit		0.233
		5 GHz limit		0.210
	10 mV/div	8 GHz		0.482
		7 GHz limit		0.440
		6 GHz limit		0.388
		5 GHz limit		0.338
	20 mV/div	8 GHz		0.890
		7 GHz limit		0.793
		6 GHz limit		0.691
		5 GHz limit		0.630
	50 mV/div	8 GHz		2.10
		7 GHz limit		1.85
		6 GHz limit		1.67
		5 GHz limit		1.49
	100 mV/div	8 GHz		4.88
		7 GHz limit		4.4
		6 GHz limit		3.83
		5 GHz limit		3.42
	1 V/div	8 GHz		42.0
		7 GHz limit		37.0
		6 GHz limit		33.4
		5 GHz limit		29.7

## Random Noise, High Res mode test record

	igh Res mode: All models	· · · · · · · · · · · · · · · · · · ·		
Performance chec			50 Ω	
Channel	V/div	Bandwidth <sup>3</sup>	Test result (mV)	High limit (mV)
Channel 1	1 mV/div	4 GHz		0.138
		3 GHz limit		0.117
		2.5 GHz limit		0.108
		2 GHz limit		0.0963
		1 GHz limit		0.0773
		500 MHz limit		0.056
		350 MHz limit		0.0477
		250 M GHz limit		0.0461
		200 MHz limit		0.0379
		20 MHz limit		0.013
	2 mV/div	4 GHz		0.139
		3 GHz limit		0.119
		2.5 GHz limit		0.110
		2 GHz limit		0.0976
		1 GHz limit		0.0724
		500 MHz limit		0.562
		350 MHz limit		0.0473
		250 M GHz limit		0.0467
		200 MHz limit		0.038
		20 MHz limit		0.0133
	5 mV/div	4 GHz		0.175
		3 GHz limit		0.149
		2.5 GHz limit		0.133
		2 GHz limit		0.118
		1 GHz limit		0.0896
		500 MHz limit		0.068
		350 MHz limit		0.0565
		250 M GHz limit		0.054
		200 MHz limit		0.0444
		20 MHz limit		0.0156

<sup>&</sup>lt;sup>3</sup> Full = the highest bandwidth setting you can select.

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth <sup>3</sup>	Test result (mV)	High limit (mV)
Channel 1	10 mV/div	4 GHz		0.271
		3 GHz limit		0.226
		2.5 GHz limit		0.203
		2 GHz limit		0.186
		1 GHz limit		0.128
		500 MHz limit		0.0919
		350 MHz limit		0.0773
		250 M GHz limit		0.0747
		200 MHz limit		0.0658
		20 MHz limit		0.0226
	20 mV/div	4 GHz		0.486
		3 GHz limit		0.398
		2.5 GHz limit		0.363
		2 GHz limit		0.320
		1 GHz limit		0.226
		500 MHz limit		0.162
		350 MHz limit		0.133
		250 M GHz limit		0.120
		200 MHz limit		0.106
		20 MHz limit		0.0412
	50 mV/div	4 GHz		1.15
		3 GHz limit		0.960
		2.5 GHz limit		0.856
		2 GHz limit		0.745
		1 GHz limit		0.534
		500 MHz limit		0.396
		350 MHz limit		0.307
		250 M GHz limit		0.280
		200 MHz limit		0.247
		20 MHz limit		0.105

	Performance chec	ks		50 Ω	
3 GHz limit 2.28 2.5 GHz limit 1.81 1 GHz limit 1.33 500 MHz limit 0.792 250 M GHz limit 0.792 200 MHz limit 0.722 200 MHz limit 0.236 1 V/div 4 GHz 2.3.1 3 GHz limit 19.2 2.5 GHz limit 1.9.2 3 GHz limit 1.9.2 2.5 GHz limit 1.9.2 3 GHz limit 1.9.3 4 GHz limit 1.9.4 500 MHz limit 1.9.8 500 MHz limit 1.9.2 350 MHz limit 1.9.2 350 MHz limit 1.9.2	Channel	V/div	Bandwidth <sup>3</sup>	Test result (mV)	High limit (mV)
2.5 GHz limit 2.03 2 GHz limit 1.81 1 GHz limit 1.33 500 MHz limit 0.941 350 MHz limit 0.792 250 M GHz limit 0.722 200 MHz limit 0.666 20 MHz limit 0.236 1 V/div 4 GHz 23.1 3 GHz limit 19.2 2.5 GHz limit 17.1 2 GHz limit 14.9 1 GHz limit 10.8 500 MHz limit 7.92 350 MHz limit 7.92 350 MHz limit 7.92 350 MHz limit 7.92 350 MHz limit 7.92	Channel 1	100 mV/div	4 GHz		2.71
2 GHz limit 1.81 1 GHz limit 1.33 500 MHz limit 0.941 350 MHz limit 0.792 250 M GHz limit 0.722 200 MHz limit 0.666 20 MHz limit 0.236 1 V/div 4 GHz 23.1 3 GHz limit 19.2 2.5 GHz limit 17.1 2 GHz limit 14.9 1 GHz limit 10.8 500 MHz limit 7.92 350 MHz limit 7.92 350 MHz limit 6.14 250 M GHz limit 5.6 200 MHz limit 4.94			3 GHz limit		2.28
1 GHz limit 1.33 500 MHz limit 0.941 350 MHz limit 0.792 250 M GHz limit 0.722 200 MHz limit 0.666 20 MHz limit 0.236 1 V/div 4 GHz 23.1 3 GHz limit 19.2 2.5 GHz limit 17.1 2 GHz limit 14.9 1 GHz limit 10.8 500 MHz limit 7.92 350 MHz limit 7.92 350 MHz limit 6.14 250 M GHz limit 5.6 200 MHz limit 4.94			2.5 GHz limit		2.03
500 MHz limit 0.941 350 MHz limit 0.792 250 M GHz limit 0.722 200 MHz limit 0.236 1 V/div 4 GHz 23.1 3 GHz limit 19.2 2.5 GHz limit 17.1 2 GHz limit 14.9 1 GHz limit 10.8 500 MHz limit 7.92 350 MHz limit 7.92 350 MHz limit 6.14 250 M GHz limit 5.6			2 GHz limit		1.81
350 MHz limit 0.792 250 M GHz limit 0.722 200 MHz limit 0.666 20 MHz limit 0.236  1 V/div 4 GHz 23.1 3 GHz limit 19.2 2.5 GHz limit 17.1 2 GHz limit 14.9 1 GHz limit 10.8 500 MHz limit 7.92 350 MHz limit 6.14 250 M GHz limit 5.6 200 MHz limit 4.94			1 GHz limit		1.33
250 M GHz limit 0.722 200 MHz limit 0.666 20 MHz limit 0.236  1 V/div 4 GHz 23.1 3 GHz limit 19.2 2.5 GHz limit 17.1 2 GHz limit 14.9 1 GHz limit 10.8 500 MHz limit 7.92 350 MHz limit 6.14 250 M GHz limit 5.6 200 MHz limit 4.94			500 MHz limit		0.941
200 MHz limit 0.666 20 MHz limit 0.236  1 V/div 4 GHz 23.1 3 GHz limit 19.2 2.5 GHz limit 17.1 2 GHz limit 14.9 1 GHz limit 10.8 500 MHz limit 7.92 350 MHz limit 6.14 250 M GHz limit 5.6 200 MHz limit 4.94			350 MHz limit		0.792
20 MHz limit 0.236  1 V/div 4 GHz 23.1  3 GHz limit 19.2  2.5 GHz limit 17.1  2 GHz limit 14.9  1 GHz limit 10.8  500 MHz limit 7.92  350 MHz limit 6.14  250 M GHz limit 5.6  200 MHz limit 4.94			250 M GHz limit		0.722
1 V/div 4 GHz 23.1 3 GHz limit 19.2 2.5 GHz limit 17.1 2 GHz limit 14.9 1 GHz limit 10.8 500 MHz limit 7.92 350 MHz limit 6.14 250 M GHz limit 5.6 200 MHz limit 4.94			200 MHz limit		0.666
3 GHz limit 19.2 2.5 GHz limit 17.1 2 GHz limit 14.9 1 GHz limit 10.8 500 MHz limit 7.92 350 MHz limit 6.14 250 M GHz limit 5.6 200 MHz limit 4.94			20 MHz limit		0.236
2.5 GHz limit       17.1         2 GHz limit       14.9         1 GHz limit       10.8         500 MHz limit       7.92         350 MHz limit       6.14         250 M GHz limit       5.6         200 MHz limit       4.94		1 V/div	4 GHz		23.1
2 GHz limit 14.9  1 GHz limit 10.8  500 MHz limit 7.92  350 MHz limit 6.14  250 M GHz limit 5.6  200 MHz limit 4.94			3 GHz limit		19.2
1 GHz limit 10.8 500 MHz limit 7.92 350 MHz limit 6.14 250 M GHz limit 5.6 200 MHz limit 4.94			2.5 GHz limit		17.1
500 MHz limit 7.92 350 MHz limit 6.14 250 M GHz limit 5.6 200 MHz limit 4.94			2 GHz limit		14.9
350 MHz limit 6.14 250 M GHz limit 5.6 200 MHz limit 4.94			1 GHz limit		10.8
250 M GHz limit 5.6 200 MHz limit 4.94			500 MHz limit		7.92
200 MHz limit 4.94			350 MHz limit		6.14
			250 M GHz limit		5.6
20 MHz limit 2.11			200 MHz limit		4.94
			20 MHz limit		2.11

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth <sup>3</sup>	Test result (mV)	High limit (mV)
Channel 2	1 mV/div	4 GHz		0.138
		3 GHz limit		0.117
		2.5 GHz limit		0.108
		2 GHz limit		0.0963
		1 GHz limit		0.0773
		500 MHz limit		0.056
		350 MHz limit		0.0477
		250 M GHz limit		0.0461
		200 MHz limit		0.0379
		20 MHz limit		0.013
	2 mV/div	4 GHz		0.139
		3 GHz limit		0.119
		2.5 GHz limit		0.110
		2 GHz limit		0.0976
		1 GHz limit		0.0724
		500 MHz limit		0.562
		350 MHz limit		0.0473
		250 M GHz limit		0.0467
		200 MHz limit		0.038
		20 MHz limit		0.0133
	5 mV/div	4 GHz		0.175
		3 GHz limit		0.149
		2.5 GHz limit		0.133
		2 GHz limit		0.118
		1 GHz limit		0.0896
		500 MHz limit		0.068
		350 MHz limit		0.0565
		250 M GHz limit		0.054
		200 MHz limit		0.0444
		20 MHz limit		0.0156

Performance ched	cks		50 Ω	
Channel	V/div	Bandwidth <sup>3</sup>	Test result (mV)	High limit (mV)
Channel 2	10 mV/div	4 GHz		0.271
		3 GHz limit		0.226
		2.5 GHz limit		0.203
		2 GHz limit		0.186
		1 GHz limit		0.128
		500 MHz limit		0.0919
		350 MHz limit		0.0773
		250 M GHz limit		0.0747
		200 MHz limit		0.0658
		20 MHz limit		0.0226
	20 mV/div	4 GHz		0.486
		3 GHz limit		0.398
		2.5 GHz limit		0.363
		2 GHz limit		0.320
		1 GHz limit		0.226
		500 MHz limit		0.162
		350 MHz limit		0.133
		250 M GHz limit		0.120
		200 MHz limit		0.106
		20 MHz limit		0.0412
	50 mV/div	4 GHz		1.15
		3 GHz limit		0.960
		2.5 GHz limit		0.856
		2 GHz limit		0.745
		1 GHz limit		0.534
		500 MHz limit		0.396
		350 MHz limit		0.307
		250 M GHz limit		0.280
		200 MHz limit		0.247
		20 MHz limit		0.105

Performance chec	ks		50 Ω	
Channel	V/div	Bandwidth <sup>3</sup>	Test result (mV)	High limit (mV)
Channel 2	100 mV/div	4 GHz		2.71
		3 GHz limit		2.28
		2.5 GHz limit		2.03
		2 GHz limit		1.81
		1 GHz limit		1.33
		500 MHz limit		0.941
		350 MHz limit		0.792
		250 M GHz limit		0.722
		200 MHz limit		0.666
		20 MHz limit		0.236
	1 V/div	4 GHz		23.1
		3 GHz limit		19.2
		2.5 GHz limit		17.1
		2 GHz limit		14.9
		1 GHz limit		10.8
		500 MHz limit		7.92
		350 MHz limit		6.14
		250 M GHz limit		5.6
		200 MHz limit		4.94
		20 MHz limit		2.11

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth <sup>3</sup>	Test result (mV)	High limit (mV
Channel 3	1 mV/div	4 GHz		0.138
		3 GHz limit		0.117
		2.5 GHz limit		0.108
		2 GHz limit		0.0963
		1 GHz limit		0.0773
		500 MHz limit		0.056
		350 MHz limit		0.0477
		250 M GHz limit		0.0461
		200 MHz limit		0.0379
		20 MHz limit		0.013
	2 mV/div	4 GHz		0.139
		3 GHz limit		0.119
		2.5 GHz limit		0.110
		2 GHz limit		0.0976
		1 GHz limit		0.0724
		500 MHz limit		0.562
		350 MHz limit		0.0473
		250 M GHz limit		0.0467
		200 MHz limit		0.038
		20 MHz limit		0.0133
	5 mV/div	4 GHz		0.175
		3 GHz limit		0.149
		2.5 GHz limit		0.133
		2 GHz limit		0.118
		1 GHz limit		0.0896
		500 MHz limit		0.068
		350 MHz limit		0.0565
		250 M GHz limit		0.054
		200 MHz limit		0.0444
		20 MHz limit		0.0156

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth <sup>3</sup>	Test result (mV)	High limit (mV)
Channel 3	10 mV/div	4 GHz		0.271
		3 GHz limit		0.226
		2.5 GHz limit		0.203
		2 GHz limit		0.186
		1 GHz limit		0.128
		500 MHz limit		0.0919
		350 MHz limit		0.0773
		250 M GHz limit		0.0747
		200 MHz limit		0.0658
		20 MHz limit		0.0226
	20 mV/div	4 GHz		0.486
		3 GHz limit		0.398
		2.5 GHz limit		0.363
		2 GHz limit		0.320
		1 GHz limit		0.226
		500 MHz limit		0.162
		350 MHz limit		0.133
		250 M GHz limit		0.120
		200 MHz limit		0.106
		20 MHz limit		0.0412
	50 mV/div	4 GHz		1.15
		3 GHz limit		0.960
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		2 GHz limit		0.745
		1 GHz limit		0.534
		500 MHz limit		0.396
		350 MHz limit		0.307
		250 M GHz limit		0.280
		200 MHz limit		0.247
		20 MHz limit		0.105

Performance chec	ks		50 Ω	
Channel	V/div	Bandwidth <sup>3</sup>	Test result (mV)	High limit (mV)
Channel 3	100 mV/div	4 GHz		2.71
		3 GHz limit		2.28
		2.5 GHz limit		2.03
		2 GHz limit		1.81
		1 GHz limit		1.33
		500 MHz limit		0.941
		350 MHz limit		0.792
		250 M GHz limit		0.722
		200 MHz limit		0.666
		20 MHz limit		0.236
	1 V/div	4 GHz		23.1
		3 GHz limit		19.2
		2.5 GHz limit		17.1
		2 GHz limit		14.9
		1 GHz limit		10.8
		500 MHz limit		7.92
		350 MHz limit		6.14
		250 M GHz limit		5.6
		200 MHz limit		4.94
		20 MHz limit		2.11

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth <sup>3</sup>	Test result (mV)	High limit (mV)
Channel 4	1 mV/div	4 GHz		0.138
		3 GHz limit		0.117
		2.5 GHz limit		0.108
		2 GHz limit		0.0963
		1 GHz limit		0.0773
		500 MHz limit		0.056
		350 MHz limit		0.0477
		250 M GHz limit		0.0461
		200 MHz limit		0.0379
		20 MHz limit		0.013
	2 mV/div	4 GHz		0.139
		3 GHz limit		0.119
		2.5 GHz limit		0.110
		2 GHz limit		0.0976
		1 GHz limit		0.0724
		500 MHz limit		0.562
		350 MHz limit		0.0473
		250 M GHz limit		0.0467
		200 MHz limit		0.038
		20 MHz limit		0.0133
	5 mV/div	4 GHz		0.175
		3 GHz limit		0.149
		2.5 GHz limit		0.133
	2 GHz limit		0.118	
		1 GHz limit		0.0896
		500 MHz limit		0.068
		350 MHz limit		0.0565
		250 M GHz limit		0.054
		200 MHz limit		0.0444
		20 MHz limit		0.0156
		· · · · · · · · · · · · · · · · · · ·		

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth <sup>3</sup>	Test result (mV)	High limit (mV)
Channel 4	10 mV/div	4 GHz		0.271
		3 GHz limit		0.226
		2.5 GHz limit		0.203
		2 GHz limit		0.186
		1 GHz limit		0.128
		500 MHz limit		0.0919
		350 MHz limit		0.0773
		250 M GHz limit		0.0747
		200 MHz limit		0.0658
		20 MHz limit		0.0226
	20 mV/div	4 GHz		0.486
		3 GHz limit		0.398
		2.5 GHz limit		0.363
		2 GHz limit		0.320
		1 GHz limit		0.226
		500 MHz limit		0.162
		350 MHz limit		0.133
		250 M GHz limit		0.120
		200 MHz limit		0.106
		20 MHz limit		0.0412
	50 mV/div	4 GHz		1.15
		3 GHz limit		0.960
		2.5 GHz limit		0.856
		2 GHz limit		0.745
		1 GHz limit		0.534
		500 MHz limit		0.396
		350 MHz limit		0.307
		250 M GHz limit		0.280
		200 MHz limit		0.247
		20 MHz limit		0.105

Performance check	S		50 Ω	
Channel	V/div	Bandwidth <sup>3</sup>	Test result (mV)	High limit (mV)
Channel 4	100 mV/div	4 GHz		2.71
		3 GHz limit		2.28
		2.5 GHz limit		2.03
		2 GHz limit		1.81
		1 GHz limit		1.33
		500 MHz limit		0.941
		350 MHz limit		0.792
		250 M GHz limit		0.722
		200 MHz limit		0.666
		20 MHz limit		0.236
	1 V/div	4 GHz		23.1
		3 GHz limit		19.2
		2.5 GHz limit		17.1
		2 GHz limit		14.9
		1 GHz limit		10.8
		500 MHz limit		7.92
		350 MHz limit		6.14
		250 M GHz limit		5.6
		200 MHz limit		4.94
	1	20 MHz limit		2.11

#### High Offset AC RMS Noise, sample acquisition mode test record

Start with the highest bandwidth setting you can select.

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)
Channel 1	1 mV/div	8 GHz		0.223
		7 GHz limit		0.199
		6 GHz limit		0.179
		5 GHz limit		0.162
	2 mV/div	8 GHz		0.224
		7 GHz limit		0.202
		6 GHz limit		0.180
		5 GHz limit		0.164
	5 mV/div	8 GHz		0.293
		7 GHz limit		0.271
		6 GHz limit		0.233
		5 GHz limit		0.210
	10 mV/div	8 GHz		0.482
		7 GHz limit		0.440
		6 GHz limit		0.388
		5 GHz limit		0.338
	20 mV/div	8 GHz		0.890
		7 GHz limit		0.793
		6 GHz limit		0.691
		5 GHz limit		0.630
	50 mV/div	8 GHz		2.10
		7 GHz limit		1.85
		6 GHz limit		1.67
		5 GHz limit		1.49
	100 mV/div	8 GHz		4.88
		7 GHz limit		4.4
		6 GHz limit		3.83
		5 GHz limit		3.42
	1 V/div	8 GHz		42.0
		7 GHz limit		37.0
		6 GHz limit		33.4
		5 GHz limit		29.7

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)
Channel 2	1 mV/div	8 GHz		0.223
		7 GHz limit		0.199
		6 GHz limit		0.179
		5 GHz limit		0.162
	2 mV/div	8 GHz		0.224
		7 GHz limit		0.202
		6 GHz limit		0.180
		5 GHz limit		0.164
	5 mV/div	8 GHz		0.293
		7 GHz limit		0.271
		6 GHz limit		0.233
		5 GHz limit		0.210
	10 mV/div	8 GHz		0.482
		7 GHz limit		0.440
		6 GHz limit		0.388
		5 GHz limit		0.338
	20 mV/div	8 GHz		0.890
		7 GHz limit		0.793
		6 GHz limit		0.691
		5 GHz limit		0.630
	50 mV/div	8 GHz		2.10
		7 GHz limit		1.85
		6 GHz limit		1.67
		5 GHz limit		1.49
	100 mV/div	8 GHz		4.88
		7 GHz limit		4.4
		6 GHz limit		3.83
		5 GHz limit		3.42
	1 V/div	8 GHz		42.0
		7 GHz limit		37.0
		6 GHz limit		33.4
		5 GHz limit		29.7

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)
Channel 3	1 mV/div	8 GHz		0.223
		7 GHz limit		0.199
		6 GHz limit		0.179
		5 GHz limit		0.162
	2 mV/div	8 GHz		0.224
		7 GHz limit		0.202
		6 GHz limit		0.180
		5 GHz limit		0.164
	5 mV/div	8 GHz		0.293
		7 GHz limit		0.271
		6 GHz limit		0.233
		5 GHz limit		0.210
	10 mV/div	8 GHz		0.482
		7 GHz limit		0.440
		6 GHz limit		0.388
		5 GHz limit		0.338
	20 mV/div	8 GHz		0.890
		7 GHz limit		0.793
		6 GHz limit		0.691
		5 GHz limit		0.630
	50 mV/div	8 GHz		2.10
		7 GHz limit		1.85
		6 GHz limit		1.67
		5 GHz limit		1.49
	100 mV/div	8 GHz		4.88
		7 GHz limit		4.4
		6 GHz limit		3.83
		5 GHz limit		3.42
	1 V/div	8 GHz		42.0
		7 GHz limit		37.0
		6 GHz limit		33.4
		5 GHz limit		29.7

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)
Channel 4	1 mV/div	8 GHz		0.223
		7 GHz limit		0.199
		6 GHz limit		0.179
		5 GHz limit		0.162
	2 mV/div	8 GHz		0.224
		7 GHz limit		0.202
		6 GHz limit		0.180
		5 GHz limit		0.164
	5 mV/div	8 GHz		0.293
		7 GHz limit		0.271
		6 GHz limit		0.233
		5 GHz limit		0.210
	10 mV/div	8 GHz		0.482
		7 GHz limit		0.440
		6 GHz limit		0.388
		5 GHz limit		0.338
	20 mV/div	8 GHz		0.890
		7 GHz limit		0.793
		6 GHz limit		0.691
		5 GHz limit		0.630
	50 mV/div	8 GHz		2.10
		7 GHz limit		1.85
		6 GHz limit		1.67
		5 GHz limit		1.49
	100 mV/div	8 GHz		4.88
		7 GHz limit		4.4
		6 GHz limit		3.83
		5 GHz limit		3.42
	1 V/div	8 GHz		42.0
		7 GHz limit		37.0
		6 GHz limit		33.4
		5 GHz limit		29.7

# High Offset AC RMS Noise, High Res mode test record

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)
Channel 1	1 mV/div	4 GHz		0.138
		3 GHz limit		0.117
		2 GHz limit		0.0963
		1 GHz limit		0.0773
		500 MHz limit		0.056
		350 MHz limit		0.0477
		250 M GHz limit		0.0461
		200 MHz limit		0.0379
		20 MHz limit		0.025
	2 mV/div	4 GHz		0.139
		3 GHz limit		0.119
		2 GHz limit		0.0976
		1 GHz limit		0.0724
		500 MHz limit		0.562
		350 MHz limit		0.0473
		250 M GHz limit		0.0467
		200 MHz limit		0.038
		20 MHz limit		0.025
	5 mV/div	4 GHz		0.175
		3 GHz limit		0.149
		2 GHz limit		0.118
		1 GHz limit		0.110
		500 MHz limit		0.100
		350 MHz limit		0.092
		250 M GHz limit		0.090
		200 MHz limit		0.080
		20 MHz limit		0.075

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)
Channel 1	10 mV/div	4 GHz		0.271
		3 GHz limit		0.226
		2 GHz limit		0.212
		1 GHz limit		0.190
		500 MHz limit		0.182
		350 MHz limit		0.165
		250 M GHz limit		0.145
		200 MHz limit		0.120
		20 MHz limit		0.115
	20 mV/div	4 GHz		0.486
		3 GHz limit		0.475
		2 GHz limit		0.450
		1 GHz limit		0.425
		500 MHz limit		0.400
		350 MHz limit		0.385
		250 M GHz limit		0.325
		200 MHz limit		0.320
		20 MHz limit		0.310
	50 mV/div	4 GHz		1.15
		3 GHz limit		0.975
		2 GHz limit		0.920
		1 GHz limit		0.900
		500 MHz limit		0.840
		350 MHz limit		0.770
		250 M GHz limit		0.675
		200 MHz limit		0.660
		20 MHz limit		0.560

	igh Res mode: All models		50.0	
Performance checks			50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)
Channel 1	100 mV/div	4 GHz		2.71
		3 GHz limit		2.28
		2 GHz limit		2.10
		1 GHz limit		1.78
		500 MHz limit		1.74
		350 MHz limit		1.70
		250 M GHz limit		1.50
		200 MHz limit		1.45
		20 MHz limit		1.40
	1 V/div	4 GHz		23.1
		3 GHz limit		21.4
		2 GHz limit		21.0
		1 GHz limit		19.2
		500 MHz limit		16.8
		350 MHz limit		16.1
		250 M GHz limit		15.8
		200 MHz limit		15.2
		20 MHz limit		13.0

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)
Channel 2	1 mV/div	4 GHz		0.138
		3 GHz limit		0.117
		2 GHz limit		0.0963
		1 GHz limit		0.0773
		500 MHz limit		0.056
		350 MHz limit		0.0477
		250 M GHz limit		0.0461
		200 MHz limit		0.0379
		20 MHz limit		0.025
	2 mV/div	4 GHz		0.139
		3 GHz limit		0.119
		2 GHz limit		0.0976
		1 GHz limit		0.0724
		500 MHz limit		0.562
		350 MHz limit		0.0473
		250 M GHz limit		0.0467
		200 MHz limit		0.038
		20 MHz limit		0.025
	5 mV/div	4 GHz		0.175
		3 GHz limit		0.149
		2 GHz limit		0.118
		1 GHz limit		0.110
		500 MHz limit		0.100
		350 MHz limit		0.092
		250 M GHz limit		0.090
		200 MHz limit		0.080
		20 MHz limit		0.075

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)
Channel 2	10 mV/div	4 GHz		0.271
		3 GHz limit		0.226
		2 GHz limit		0.212
		1 GHz limit		0.190
		500 MHz limit		0.182
		350 MHz limit		0.165
		250 M GHz limit		0.145
		200 MHz limit		0.120
		20 MHz limit		0.115
	20 mV/div	4 GHz		0.486
		3 GHz limit		0.475
		2 GHz limit		0.450
		1 GHz limit		0.425
		500 MHz limit		0.400
		350 MHz limit		0.385
		250 M GHz limit		0.325
		200 MHz limit		0.320
		20 MHz limit		0.310
	50 mV/div	4 GHz		1.15
		3 GHz limit		0.975
		2 GHz limit		0.920
		1 GHz limit		0.900
		500 MHz limit		0.840
		350 MHz limit		0.770
		250 M GHz limit		0.675
		200 MHz limit		0.660
		20 MHz limit		0.560

Random Noise, Hig	gh Res mode: All models			
Performance chec	ks		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)
Channel 2	100 mV/div	4 GHz		2.71
		3 GHz limit		2.28
		2 GHz limit		2.10
		1 GHz limit		1.78
		500 MHz limit		1.74
		350 MHz limit		1.70
		250 M GHz limit		1.50
		200 MHz limit		1.45
		20 MHz limit		1.40
	1 V/div	4 GHz		23.1
		3 GHz limit		21.4
		2 GHz limit		21.0
		1 GHz limit		19.2
		500 MHz limit		16.8
		350 MHz limit		16.1
		250 M GHz limit		15.8
		200 MHz limit		15.2
		20 MHz limit		13.0

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)
Channel 3	1 mV/div	4 GHz		0.138
		3 GHz limit		0.117
		2 GHz limit		0.0963
		1 GHz limit		0.0773
		500 MHz limit		0.056
		350 MHz limit		0.0477
		250 M GHz limit		0.0461
		200 MHz limit		0.0379
		20 MHz limit		0.025
	2 mV/div	4 GHz		0.139
		3 GHz limit		0.119
		2 GHz limit		0.0976
		1 GHz limit		0.0724
		500 MHz limit		0.562
		350 MHz limit		0.0473
		250 M GHz limit		0.0467
		200 MHz limit		0.038
		20 MHz limit		0.025
	5 mV/div	4 GHz		0.175
		3 GHz limit		0.149
		2 GHz limit		0.118
		1 GHz limit		0.110
		500 MHz limit		0.100
		350 MHz limit		0.092
		250 M GHz limit		0.090
		200 MHz limit		0.080
		20 MHz limit		0.075

Performance chec	cks		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)
Channel 3	10 mV/div	4 GHz		0.271
		3 GHz limit		0.226
		2 GHz limit		0.212
		1 GHz limit		0.190
		500 MHz limit		0.182
		350 MHz limit		0.165
		250 M GHz limit		0.145
		200 MHz limit		0.120
		20 MHz limit		0.115
	20 mV/div	4 GHz		0.486
		3 GHz limit		0.475
		2 GHz limit		0.450
		1 GHz limit		0.425
		500 MHz limit		0.400
		350 MHz limit		0.385
		250 M GHz limit		0.325
		200 MHz limit		0.320
		20 MHz limit		0.310
	50 mV/div	4 GHz		1.15
		3 GHz limit		0.975
		2 GHz limit		0.920
		1 GHz limit		0.900
		500 MHz limit		0.840
		350 MHz limit		0.770
		250 M GHz limit		0.675
		200 MHz limit		0.660
		20 MHz limit		0.560

Random Noise, Hi	igh Res mode: All models			
Performance checks			50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)
Channel 3	100 mV/div	4 GHz		2.71
		3 GHz limit		2.28
		2 GHz limit		2.10
		1 GHz limit		1.78
		500 MHz limit		1.74
		350 MHz limit		1.70
		250 M GHz limit		1.50
		200 MHz limit		1.45
		20 MHz limit		1.40
	1 V/div	4 GHz		23.1
		3 GHz limit		21.4
		2 GHz limit		21.0
		1 GHz limit		19.2
		500 MHz limit		16.8
		350 MHz limit		16.1
		250 M GHz limit		15.8
		200 MHz limit		15.2
		20 MHz limit		13.0

Performance chec	ks		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)
Channel 4	1 mV/div	4 GHz		0.138
		3 GHz limit		0.117
		2 GHz limit		0.0963
		1 GHz limit		0.0773
		500 MHz limit		0.056
		350 MHz limit		0.0477
		250 M GHz limit		0.0461
		200 MHz limit		0.0379
		20 MHz limit		0.025
	2 mV/div	4 GHz		0.139
		3 GHz limit		0.119
		2 GHz limit		0.0976
		1 GHz limit		0.0724
		500 MHz limit		0.562
		350 MHz limit		0.0473
		250 M GHz limit		0.0467
		200 MHz limit		0.038
		20 MHz limit		0.025
	5 mV/div	4 GHz		0.175
		3 GHz limit		0.149
		2 GHz limit		0.118
		1 GHz limit		0.110
		500 MHz limit		0.100
		350 MHz limit		0.092
		250 M GHz limit		0.090
		200 MHz limit		0.080
		20 MHz limit		0.075

Performance checks			50 Ω		
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	
Channel 4	10 mV/div	4 GHz		0.271	
		3 GHz limit		0.226	
		2 GHz limit		0.212	
		1 GHz limit		0.190	
		500 MHz limit		0.182	
		350 MHz limit		0.165	
		250 M GHz limit		0.145	
		200 MHz limit		0.120	
		20 MHz limit		0.115	
	20 mV/div	4 GHz		0.486	
		3 GHz limit		0.475	
		2 GHz limit		0.450	
		1 GHz limit		0.425	
		500 MHz limit		0.400	
		350 MHz limit		0.385	
		250 M GHz limit		0.325	
		200 MHz limit		0.320	
		20 MHz limit		0.310	
	50 mV/div	4 GHz		1.15	
		3 GHz limit		0.975	
		2 GHz limit		0.920	
		1 GHz limit		0.900	
		500 MHz limit		0.840	
		350 MHz limit		0.770	
		250 M GHz limit		0.675	
		200 MHz limit		0.660	
		20 MHz limit		0.560	

Performance checks			50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)
Channel 4	100 mV/div	4 GHz		2.71
		3 GHz limit		2.28
		2 GHz limit		2.10
		1 GHz limit		1.78
		500 MHz limit		1.74
		350 MHz limit		1.70
		250 M GHz limit		1.50
		200 MHz limit		1.45
		20 MHz limit		1.40
	1 V/div	4 GHz		23.1
		3 GHz limit		21.4
		2 GHz limit		21.0
		1 GHz limit		19.2
		500 MHz limit		16.8
		350 MHz limit		16.1
		250 M GHz limit		15.8
		200 MHz limit		15.2
		20 MHz limit		13.0

Long term sample rate	Low limit	Test result	High limit		
Performance checks					
Long term sample rate	9.999997 MHz		10.000003 MHz		

AUX Out output voltage levels					
Performance checks	Vout	Low limit	Test result	High limit	
1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1	Max	≥ 1.0 V		n/a	
Impedance,	Min	n/a		≤ 250 mV	

DVM voltage accuracy (DC)					
Channel 1					
Vertical Scale	Input Voltage	Offset Voltage	Low limit	Test result	High limit
1	-5	<b>-</b> 5	-5.125		-4.875
0.5	-2	-2	-2.06		-1.94
0.5	<b>-</b> 1	-0.5	-1.06		-0.94
Table continued	<u> </u>	-	'	•	<u>'</u>

DVM voltage acc	uracy (DC)				
0.2	-0.5	-0.5	-0.5225		-0.4775
0.01	0.002	0	0.00097		0.00303
0.2	0.5	0.5	0.4775		0.5225
0.5	1	0.5	0.94		1.06
0.5	2	2	1.94		2.06
1	5	5	4.875		5.125
Channel 2				l	
Vertical Scale	Input Voltage	Offset Voltage	Low limit	Test result	High limit
1	<b>-</b> 5	-5	-5.125		-4.875
0.5	-2	-2	-2.06		-1.94
0.5	-1	-0.5	-1.06		-0.94
0.2	-0.5	-0.5	-0.5225		-0.4775
0.01	0.002	0	0.00097		0.00303
0.2	0.5	0.5	0.4775		0.5225
0.5	1	0.5	0.94		1.06
0.5	2	2	1.94		2.06
1	5	5	4.875		5.125
Channel 3					
Vertical Scale	Input Voltage	Offset Voltage	Low limit	Test result	High limit
1	-5	-5	-5.125		-4.875
0.5	-2	-2	-2.06		-1.94
0.5	-1	-0.5	-1.06		-0.94
0.2	-0.5	-0.5	-0.5225		-0.4775
0.01	0.002	0	0.00097		0.00303
0.2	0.5	0.5	0.4775		0.5225
0.5	1	0.5	0.94		1.06
0.5	2	2	1.94		2.06
1	5	5	4.875		5.125
Channel 4	I			I	1
Vertical Scale	Input Voltage	Offset Voltage	Low limit	Test result	High limit
1	-5	-5	-5.125		-4.875
0.5	-2	-2	-2.06		-1.94
0.5	_1	-0.5	-1.06		-0.94
0.2	-0.5	-0.5	-0.5225		-0.4775
0.01	0.002	0	0.00097		0.00303
	0.5	0.5	0.4775		0.5225
0.2	[0.5]	0.0		1	1
0.2	1	0.5	0.94		1.06

DVM voltage accuracy (DC)					
1	5	5	4.875		5.125

DVM voltage accura	acy (AC)			
All models				
Channel 1				
Vertical Scale	Input Signal	Low limit	Test result	High limit
5 mV	20 mV <sub>pp</sub> at 1 kHz	9.700 mV		10.300 mV
10 mV	50 mV <sub>pp</sub> at 1 kHz	24.25 mV		25.750 mV
100 mV	0.5 V <sub>pp</sub> at 1 kHz	242.500 mV		257.500 mV
200 mV	1 V <sub>pp</sub> at 1 kHz	485.000 mV		515.000 mV
1 V	5 V <sub>pp</sub> at 1 kHz	2.425 V		2.575 V
Channel 2				
Vertical Scale	Input Signal	Low limit	Test result	High limit
5 mV	20 mV <sub>pp</sub> at 1 kHz	9.700 mV		10.300 mV
10 mV	50 mV <sub>pp</sub> at 1 kHz	24.25 mV		25.750 mV
100 mV	0.5 V <sub>pp</sub> at 1 kHz	242.500 mV		257.500 mV
200 mV	1 V <sub>pp</sub> at 1 kHz	485.000 mV		515.000 mV
1 V	5 V <sub>pp</sub> at 1 kHz	2.425 V		2.575 V
Channel 3	·		·	·
Vertical Scale	Input Signal	Low limit	Test result	High limit
5 mV	20 mV <sub>pp</sub> at 1 kHz	9.700 mV		10.300 mV
10 mV	50 mV <sub>pp</sub> at 1 kHz	24.25 mV		25.750 mV
100 mV	0.5 V <sub>pp</sub> at 1 kHz	242.500 mV		257.500 mV
200 mV	1 V <sub>pp</sub> at 1 kHz	485.000 mV		515.000 mV
1 V	5 V <sub>pp</sub> at 1 kHz	2.425 V		2.575 V
Channel 4			·	
Vertical Scale	Input Signal	Low limit	Test result	High limit
5 mV	20 mV <sub>pp</sub> at 1 kHz	9.700 mV		10.300 mV
10 mV	50 mV <sub>pp</sub> at 1 kHz	24.25 mV		25.750 mV
100 mV	0.5 V <sub>pp</sub> at 1 kHz	242.500 mV		257.500 mV
200 mV	1 V <sub>pp</sub> at 1 kHz	485.000 mV		515.000 mV
1 V	5 V <sub>pp</sub> at 1 kHz	2.425 V		2.575 V

Trigger frequency accuracy and trigger frequency counter maximum input frequency	
All models	
Table continued	

Channel 1				
	Hz	Low limit	Test result	High limit
	100 Hz	99.99995 Hz		1000.0005 Hz
	1000 Hz	999.9995 Hz		10000.005 Hz
	10 kHz	9.999995 KHz		10.000005 kHz
	100 kHz	99.99995 kHz		100.00005 kHz
	1000 kHz	999.9995 kHz		1000.0005 kHz
	10 MHz	9.999995 MHz		10.000005 MHz
	100 MHz	99.99995 MHz		100.00005 MHz
	1000 MHz	999.9995 MHz		1000.0005 MHz
	2000 MHz	1999.999 MHz		2000.001 MHz
	4000 MHz	3999.998 MHz		4000.002 MHz
	8000 MHz	7999.996 MHz		8000.004 MHz
hannel 2	<u>'</u>			
	Hz	Low limit	Test result	High limit
	100 Hz	99.99995 Hz		1000.0005 Hz
	1000 Hz	999.9995 Hz		10000.005 Hz
	10 kHz	9.999995 KHz		10.000005 kHz
	100 kHz	99.99995 kHz		100.00005 kHz
	1000 kHz	999.9995 kHz		1000.0005 kHz
	10 MHz	9.999995 MHz		10.000005 MHz
	100 MHz	99.99995 MHz		100.00005 MHz
	1000 MHz	999.9995 MHz		1000.0005 MHz
	2000 MHz	1999.999 MHz		2000.001 MHz
	4000 MHz	3999.998 MHz		4000.002 MHz
	8000 MHz	7999.996 MHz		8000.004 MHz

	Hz	Low limit	Test result	High limit
	100 Hz	99.99995 Hz		1000.0005 Hz
	1000 Hz	999.9995 Hz		10000.005 Hz
	10 kHz	9.999995 KHz		10.000005 kHz
	100 kHz	99.99995 kHz		100.00005 kHz
	1000 kHz	999.9995 kHz		1000.0005 kHz
	10 MHz	9.999995 MHz		10.000005 MHz
	100 MHz	99.99995 MHz		100.00005 MHz
	1000 MHz	999.9995 MHz		1000.0005 MHz
	2000 MHz	1999.999 MHz		2000.001 MHz
	4000 MHz	3999.998 MHz		4000.002 MHz
	8000 MHz	7999.996 MHz		8000.004 MHz
annel 4		<u>'</u>		<u>'</u>
	Hz	Low limit	Test result	High limit
	100 Hz	99.99995 Hz		1000.0005 Hz
	1000 Hz	999.9995 Hz		10000.005 Hz
	10 kHz	9.999995 KHz		10.000005 kHz
	100 kHz	99.99995 kHz		100.00005 kHz
	1000 kHz	999.9995 kHz		1000.0005 kHz
	10 MHz	9.999995 MHz		10.000005 MHz
	100 MHz	99.99995 MHz		100.00005 MHz
	1000 MHz	999.9995 MHz		1000.0005 MHz
	2000 MHz	1999.999 MHz		2000.001 MHz
	4000 MHz	3999.998 MHz		4000.002 MHz
	8000 MHz	7999.996 MHz		8000.004 MHz

AFG sine and ramp frequency accuracy						
Performance checks						
Waveform type	Waveform type Minimum Test result Maximum					
Sine, 1 MHz 0.999950 MHz 1.000050 MHz						
Ramp, 500 KHz	499.975 kHz		500.025 kHz			

AFG square and pulse frequency accuracy						
Performance checks						
Waveform type	Waveform type Minimum Test result Maximum					
Square, 1 MHz         0.999950 MHz         1.000050 MHz						
Pulse, 1 MHz	0.999950 MHz		1.000050 MHz			

AFG signal amplitude accuracy						
Performance checks						
Amplitude	Minimum	Test result	Maximum			
30.0 mV <sub>PP</sub>	28.55 mV <sub>PP</sub>		31.45 mV <sub>PP</sub>			
300.0 mV <sub>PP</sub>	294.5 mV <sub>PP</sub>		305.5 mV <sub>PP</sub>			
800.0 mV <sub>PP</sub>	787.0 mV <sub>PP</sub>		813.0 mV <sub>PP</sub>			
1.500 V <sub>PP</sub>	1.4765 V <sub>PP</sub>		1.5235 V <sub>PP</sub>			
2.000 V <sub>PP</sub>	1.9690 V <sub>PP</sub>		2.0310 V <sub>PP</sub>			
2.500 V <sub>PP</sub>	2.4615 V <sub>PP</sub>		2.5385 V <sub>PP</sub>			

AFG DC offset accuracy					
Performance checks					
Offset	Minimum	Test result	Maximum		
1.25 V	1.23025 Vdc		1.26975 Vdc		
0 V	- 0.001 Vdc		+ 0.001 Vdc		
-1.25 V	- 1.26975 Vdc		- 1.23025 Vdc		

## **Performance tests**

This section contains a collection of manual procedures for checking that the instrument performs as warranted. They check all the characteristics that are designated as checked in *Specifications*). (The characteristics that are checked appear with a ✓ in *Specifications*).

#### **Prerequisites**

The tests in this section comprise an extensive, valid confirmation of performance and functionality when the following requirements are met:

- The instrument must be in its normal operating configuration (no covers removed).
- You must have performed and passed the procedures under Self Test. (See Self test on page 78.)
- A signal-path compensation must have been done within the recommended calibration interval and at a temperature within ±5 °C (±9 °F) of the present operating temperature. (If the temperature was within the limits just stated at the time you did the prerequisite Self Test, consider this prerequisite met). A signal-path compensation must have been done at an ambient humidity within 25% of the current ambient humidity and after having been at that humidity for at least 4 hours.
- The instrument must have been last adjusted at an ambient temperature between +18 °C and +28 °C (+64 °F and +82 °F), must have been operating for a warm-up period of at least 20 minutes, and must be operating at an ambient temperature as listed in the specifications. The warm-up requirement is usually met in the course of meeting the Self Test prerequisites listed above.
- The instrument must be powered from a source maintaining voltage and frequency within the limits described in the *Specifications* section.
- The instrument must be in an environment with temperature, altitude, humidity, and vibration within the operating limits described in the Specifications section.

#### Self test

This procedure verifies that the instrument passes the internal diagnostics and performs signal path compensation. No test equipment or hookups are required.

Equipment required	Prerequisites		
None	Power on the instrument and allow a 20 minute warm-up period		
	before performing this procedure.		

- 1. Run the System Diagnostics (may take a few minutes):
  - a. Disconnect all probes and/or cables from the oscilloscope inputs.
  - b. Tap Utility > Self Test. This displays the Self Test configuration menu.
  - c. Tap the Run Self Test button.
  - **d.** The internal diagnostics perform an exhaustive verification of proper instrument function. This verification may take several minutes. When the verification is finished, the status of each self test is shown in the menu.
  - e. Verify that the status of all tests is .
  - f. Tap anywhere outside the menu to exit the menu.
- 2. Run the signal-path compensation routine (may take 5 to 15 minutes per channel):
  - a. Tap Utility > Calibration. This displays the Calibration configuration menu.
  - **b.** Tap the **Run SPC** button to start the routine.
  - **c.** Signal-path compensation may take 5 to 15 minutes to run per channel.
  - d. Verify that the SPC Status is Passed.
- 3. Return to regular service: Tap anywhere outside the menu to exit the Calibration menu.

The self test procedures are completed. If any of the above tests failed, run the tests again. If there are still failures, contact Tektronix Customer Support.



Note: You cannot run the remaining performance tests until the self tests pass and the SPC has successfully run.

### **Check input impedance**

This test checks the input impedance on all channels.

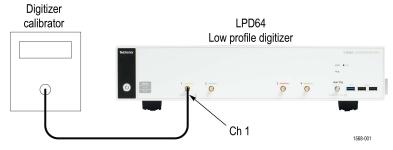
1. Connect the output of the digitizer calibrator (for example, Fluke 9500) to the digitizer channel 1 input, as shown in the following illustration.



**WARNING:** Be sure to set the generator to Off or 0 volts before connecting, disconnecting, and/or moving the test hookup during the performance of this procedure. The generator is capable of providing dangerous voltages.



**Note:** Impedance measuring equipment that produces a voltage across the channel that exceeds the measurement range of the instrument may report erroneous impedance results. A measurement voltage exceeds the measurement range of the instrument when the resulting trace is not visible on the graticule.



- **2.** Test 50  $\Omega$  input impedance as follows:
  - a. Set the calibrator impedance to measure 50  $\Omega$  impedance.
  - **b.** Double-tap the **Ch 1** badge and set **Termination** to **50**  $\Omega$ .
- **3.** Repeat the procedures for all remaining channels as follows:
  - a. Turn the calibrator output Off.
  - **b.** Move the calibrator connection to the next channel to test.
  - c. Double-tap the channel badge of the channel that you have finished testing and set Display to Off.
  - d. Tap the channel button on the Settings bar of the next channel to test.
  - e. Starting from step 2 on page 79, repeat the procedures until all channels have been tested.

### **Check DC balance**

This test checks the DC balance. You do not need to connect any test equipment (other than the 50  $\Omega$  terminator) to the oscilloscope to perform this check.

LPD64 Low profile digitizer



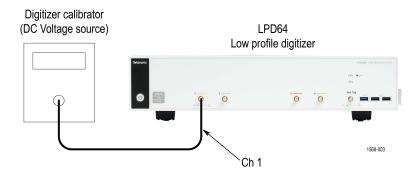
- 1. Attach a 50  $\Omega$  terminator to the oscilloscope channel 1 input.
- 2. Tap File > Default Setup.
- 3. Double-tap the Horizontal badge on the Settings bar and set the Horizontal Scale to 1 ms/div.
- **4.** Tap the channel **1** button on the oscilloscope Settings bar to display a channel badge.
- 5. Double tap the **Ch 1** badge to open its menu.
- 6. Set the Vertical Scale to 1 mV/div.
- 7. Set the channel 1 **Termination** to **50**  $\Omega$ .
- 8. Tap the Bandwidth Limit field and select 20 MHz.
- 9. Tap outside the menu to close it.
- 10. Double-tap the Acquisition badge and set the Acquisition Mode to Average.
- 11. Set the Number of Waveforms to 16.
- 12. Tap outside the menu to close it.
- 13. Double-tap the **Trigger** badge and set the **Source** to **AC line**.
- **14.** Tap outside the menu to close it.
- 15. Add a Mean amplitude measurement for channel 1 to the Results bar:
  - a. Tap the Add New... Measure button to open the Add Measurements menu.
  - b. Set the Source to Ch 1.
  - c. In the Amplitude Measurements panel, double-tap the Mean button to add the Mean measurement badge to the Results bar.
- 16. Tap outside the menu to close it.
- 17. Double-tap the Mean results badge.
- 18. Tap Show Statistics in Badge.
- 19. Tap FILTER/LIMIT RESULTS to open the panel.
- 20. Tap Limit Measurement Population to toggle it to On.
- 21. Tap outside the menu to close it.
- 22. Enter the mean value as the test result in the test record.
- 23. Repeat steps 6 on page 80 through 22 on page 80 for each vertical scale setting in the test record.
- 24. Repeat steps 3 on page 80 through 23 on page 80 for each bandwidth setting in the test record table.
- 25. Repeat the procedure for all remaining channels as follows:
  - **a.** Move the 50  $\Omega$  terminator to the next channel input to be tested.
  - b. Double-tap the channel badge of the channel that you have finished testing and set **Display** to **Off**.
  - **c.** Tap the channel button on the Settings bar of the next channel to test.
  - **d.** Starting from step 6 on page 80, repeat the procedures until all channels have been tested. To change the source for the Mean measurement for each channel test:

- i. Double-tap the **Mean** measurement badge.
- ii. Tap the Configure panel.
- iii. Tap the **Source 1** field and select the next channel to test.
- 26. Tap outside the menu area to close the configuration menu.

#### Check DC gain accuracy

This test checks the DC gain accuracy.

 Connect the digitizer to a calibrated DC voltage source. If you are using the Fluke 9500 calibrator, connect the calibrator head to the digitizer channel to test.



**WARNING:** Set the generator output to Off or 0 volts before connecting, disconnecting, and/or moving the test hookup during the performance of this procedure. The generator is capable of providing dangerous voltages.

- 2. Tap File > Default Setup.
- 3. Double-tap the Acquisition badge and set Acquisition Mode to Average.
- 4. Set the Number of Waveforms to 16.
- **5.** Tap outside the menu to close the menu.
- **6.** Double-tap the **Trigger** badge and set the trigger **Source** to **AC line**.
- 7. Tap outside the menu to close it.
- 8. Add the **Mean** measurement to the Results bar:
  - a. Tap the Add New... Measure button to open the Add Measurements menu.
  - b. Set the Source to Ch 1.
  - c. In the Amplitude Measurements panel, double-tap the Mean button to add the Mean measurement badge to the Results bar.
- **9.** Tap outside the menu to close it.
- **10.** Double-tap the **Mean** results badge.
- 11. Tap Show Statistics in Badge.
- 12. Tap FILTER/LIMIT RESULTS to open the panel.
- 13. Tap Limit Measurement Population to toggle it to On.
- **14.** Tap outside the menu to close it.
- 15. Tap the channel button of the channel to test, to add the channel badge to the Settings bar.
- **16.** Double tap the channel to test badge to open its menu and set the channel settings:
  - a. Set Vertical Scale to 1 mV/div.
  - **b.** Set **Termination** to **50**  $\Omega$ .
  - c. Tap Bandwidth Limit and set to 20 MHz.

- d. Tap outside the menu to close it.
- 17. Record the negative-measured and positive-measured mean readings in the Gain expected worksheet as follows:
  - **a.** On the calibrator, set the DC Voltage Source to the V<sub>negative</sub> value as listed in the 1`mV row of the worksheet.
  - b. Double-tap the Acquisition badge and tap Clear to reset the measurement statistics.
  - $\boldsymbol{c.}$  Enter the  $\boldsymbol{Mean}$  reading in the worksheet as  $\boldsymbol{V}_{negative\text{-}measured}$
  - **d.** On the calibrator, set the DC Voltage Source to V<sub>positive</sub> value as listed in the 1`mV row of the worksheet.
  - e. Double-tap the Acquisition badge (if not open) and tap Clear.
  - f. Enter the **Mean** reading in the worksheet as V<sub>positive-measured</sub>.

Table 7: Gain expected worksheet

Digitizer Vertical Scale Setting	V <sub>diffExpected</sub>	V <sub>negative</sub>	V <sub>positive</sub>	V <sub>negative</sub> -	V <sub>positive</sub> -	V <sub>diff</sub>	Test Result (Gain Accuracy)
1 mV/div	9 mV	-4.5 mV	+4.5 mV				
2 mV/div	18 mV	-9 mV	+9 mV				
5 mV/div	45 mV	-22.5 mV	+22.5 mV				
10 mV/div	90 mV	-45 mV	+45 mV				
20 mV/div	180 mV	-90 mV	+90 mV				
50 mV/div	450 mV	-225 mV	+225 mV				
100 mV/div	900 mV	-450 mV	+450 mV				
200 mV/div	1800 mV	-900 mV	+900 mV				
500 mV/div	4900 mV	-2450 mV	+2450 mV				
1.0 V/div	9000 mV	-4500 mV	+4500 mV				
20 mV/div at 250 MHz	180 mV	-90 mV	+90 mV				
20 mV/div at Full bandwidth	180 mV	-90 mV	+90 mV				

- **18.** Calculate Gain Accuracy as follows:
  - **a.** Calculate *V* <sub>diff</sub> as follows:

- **b.** Enter *V* <sub>diff</sub> in the worksheet.
- c. Calculate Gain Accuracy as follows:

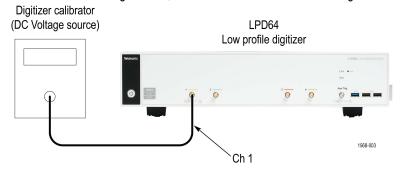
- d. Enter the Gain Accuracy value in the worksheet and in the test record.
- 19. Repeat steps 16 on page 81 through 18 on page 82 for all vertical scale settings in the work sheet and the test record.
- **20.** Repeat the procedure for all remaining channels:
  - a. Set the calibrator to 0 volts and 50  $\Omega$  output impedance.
  - **b.** Move the calibrator output to the next channel input to be tested.
  - c. Double-tap the channel badge of the channel that you have finished testing and set Display to Off.
  - d. Double-tap the **Mean** measurement badge.
  - e. Tap the Configure panel.

- f. Tap the Source 1 field and select the next channel to test.
- g. Starting from step16 on page 81, set the values from the test record for the channel under test, and repeat the above steps until all channels have been tested.
- 21. Touch outside a menu to close the menu.

# **Check DC offset accuracy**

This test checks the offset accuracy at 50  $\Omega$  and 1 M $\Omega$  input impedances.

Connect the digitizer to a calibrated DC voltage source. If you are using the Fluke 9500B calibrator as the DC voltage source, connect the calibrator head to the digitizer channel 1.



 $\wedge$ 

**WARNING:** Set the generator output to Off or 0 volts before connecting, disconnecting, or moving the test hookup during the performance of this procedure. The generator is capable of providing dangerous voltages.

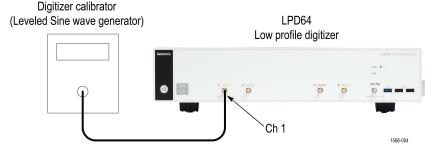
- 2. Tap File > Default Setup.
- 3. Double-tap the Acquisition badge and set Acquisition Mode to Average.
- 4. Set the Number of Waveforms to 16.
- **5.** Tap outside the menu to close the menu.
- 6. Double-tap the **Trigger** badge and set the trigger **Source** to **AC line**.
- 7. Add the **Mean** measurement to the Results bar:
  - a. Tap the Add New... Measure button to open the Add Measurements menu.
  - b. Set the Source to Ch 1.
  - c. In the Amplitude Measurements panel, double-tap the Mean button to add the Mean measurement badge to the Results bar.
- 8. Tap outside the menu to close it.
- 9. Double-tap the **Mean** results badge.
- 10. Tap Show Statistics in Badge.
- 11. Tap FILTER/LIMIT RESULTS to open the panel.
- 12. Tap Limit Measurement Population to toggle it to On.
- 13. Tap outside the menu to close it.
- 14. Tap the channel button on the Settings bar to add the channel under test to the Settings bar.
- 15. Double-tap the channel under test badge to open its configuration menu and change the vertical settings:
  - a. Set Vertical Scale to 1 mV/div.
  - b. Set Offset to 900 mV.
  - c. Set Position to 0 by tapping Set to 0.
  - d. Set Termination to 50  $\Omega$ .
  - e. Tap Bandwidth Limit and set to 20 MHz.

- f. Tap outside the menu to close it.
- 16. Set the calibrator output to +900 mV, as shown in the test record, and turn the calibrator output On.
- 17. Enter the Mean measurement value in the test record.
- 18. Double-tap the channel under test badge to open its configuration menu and change the Offset to -900 mV.
- 19. Set the calibrator output to -900 mV, as shown in the test record.
- **20.** Enter the Mean measurement value in the test record.
- 21. Repeat step 15 on page 83 through 20 on page 84, changing the channel vertical settings and the calibrator output as listed in the test record for the channel under test.
- **22.** Repeat the procedure for all remaining channels as follows:
  - **a.** Double-tap the **Mean** measurement badge.
  - **b.** Tap the **Configure** panel.
  - c. Tap the Source 1 field and select the next channel to test.
  - **d.** Set the calibrator to  $\mathbf{0}$  volts and  $\mathbf{50}$   $\mathbf{\Omega}$  output impedance.
  - e. Move the calibrator output to the next channel input to test.
  - f. Double-tap the channel badge of the channel that you have finished testing and set Display to Off.
  - g. Tap the channel button on the digitizer Settings bar of the next channel to test.
  - h. Starting from step , repeat the procedure until all channels have been tested.

# Check analog bandwidth

This test checks the bandwidth at 50  $\Omega$  for each channel.

1. Connect the output of the calibrated leveled sine wave generator to the digitizer channel 1 input as shown in the following illustration.



**WARNING:** Set the generator to off or 0 volts before connecting, disconnecting, and/or moving the test hookup during the performance of this procedure. The generator is capable of providing dangerous voltages.

- 2. Tap File > Default Setup to reset the instrument and add the channel 1 badge and signal to the display.
- 3. Add the peak-to-peak measurement as follows:
  - a. Tap the Add New. Measure button.
  - **b.** Set the **Source** to the channel under test.
  - c. In the Amplitude Measurements panel, double-tap the Peak-to-Peak measurement button to add the measurement badge to the Results bar.
  - **d.** Tap outside the menu to close it.
  - e. Double-tap the Peak-to-Peak results badge.
  - f. Tap Show Statistics in Badge.
  - g. Tap FILTER/LIMIT RESULTS to open the panel.
  - h. Tap Limit Measurement Population to toggle it to On.

- i. Tap outside the menu to close it.
- 4. Set the channel under test settings:
  - a. Double-tap the badge of the channel under test to open its configuration menu.
  - b. Set Vertical Scale to 1 mV/div.
  - c. Set Termination to 50  $\Omega$ .
  - d. Tap outside the menu to close it.
- 5. Adjust the leveled sine wave signal source to display a waveform of 8 vertical divisions at the selected vertical scale with a set frequency of 10 MHz. For example, at 5 mV/div, use a ≥40 mV<sub>p-p</sub> signal; at 2 mV/div, use a ≥16 mV<sub>p-p</sub> signal.



**Note:** At some V/div settings, the generator may not provide 8 vertical divisions of signal. Set the generator output to obtain as many vertical divisions of signal as possible.

- 6. Double-tap the Horizontal badge in the Settings bar.
- 7. Set the Horizontal Scale to 1 ms/division.
- **8.** Tap outside the menu to close it.
- **9.** Record the **Peak-to-Peak** measurement in the  $V_{in-pp}$  entry of the test record.
- **10.** Double-tap the **Horizontal** badge in the Settings bar.
- 11. Set the Horizontal Scale to .
- 12. Adjust the signal source to the maximum bandwidth frequency for the bandwidth and model being tested.
- **13.** Record the peak-to-peak measurement as follows:
  - a. Record the **Peak-to-Peak** measurement at the new frequency in the **V** bw-pp entry of the test record.
- 14. Use the values of V bw-pp and V in-pp recorded in the test record, and the following equation, to calculate the Gain at bandwidth:

Gain = Vbw-pp / Vin-pp.

To pass the performance measurement test, Gain should be  $\geq$  0.707. Enter *Gain* in the test record.

- **15.** Repeat steps 4 on page 85 through 14 on page 85 for all combinations of Vertical Scale settings listed in the test record.
- **16.** Repeat the test for all remaining channels as follows:
  - a. Set the calibrator to 0 volts and 50  $\Omega$  output impedance.
  - **b.** Move the calibrator output to the next channel input to be tested.
  - c. Double-tap the channel badge of the channel that you have finished testing and set Display to Off.
  - d. Tap the channel button on the digitizer Settings bar of the next channel to test.
  - e. Double-tap the Peak-to-Peak measurement badge.
  - f. Tap the Configure panel.
  - g. Tap the Source 1 field and select the next channel to test.
  - **h.** Starting from step 4 on page 85, repeat the procedure until all channels have been tested.

## Check random noise, Sample acquisition mode (8 and 6 GHz options)

This test checks random noise at 50  $\Omega$  for each channel in Sample acquisition mode. You do not need to connect any test equipment to the digitizer for this test.

- 1. Disconnect everything from the digitizer inputs.
- 2. Tap File > Default Setup.
- 3. Add the AC RMS measurement:
  - a. Tap the Add New... Measure button.
  - **b.** Set the **Source** to the channel being tested.
  - c. In the Amplitude Measurements panel, double-tap the AC RMS measurement button to add the measurement badge to the Results bar.
  - **d.** Tap outside the menu to close it.
  - e. Double-tap the AC RMS measurement badge and tap Show Statistics in Badge to display statistics in the measurement badge.
  - f. Tap the Filter / Limit Results panel.
  - g. Turn on Limit Measurement Population.
  - h. Set the limit to 100.
  - i. Tap outside the menu to close it.
- 4. Set up the Horizontal mode:
  - a. Double-tap the Horizontal setting badge.
  - b. Set Horizontal Mode to Manual.
  - c. Set the Sample Rate to 25 GS/s.
  - d. Set the Record Length to 2 Mpts.
  - e. Tap outside the menu to close it.
- 5. Double-tap the Channel badge of the channel being tested.
- 6. Set the **Vertical Scale** value to **1 mV**.
- 7. Check **50**  $\Omega$  termination as follows:
  - a. In the Channel badge, set **Termination** to **50**  $\Omega$ .
  - b. Tap the Bandwidth Limit field and select the highest frequency listed.
  - c. Set the channel vertical Position value to 340 mdivs.
  - d. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the μ readout).
  - e. Set the channel vertical Position value to 360 mdivs.
  - f. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the μ readout).
  - g. Average the two values and record the result in the 1 mV/div row of the 50 Ω column of the Test Result record.
- 8. Repeat step 7 on page 86 for all frequencies above 4 GHz
- **9.** Repeat the 50  $\Omega$  test at all V/div settings for the current channel:
  - a. In the Channel badge, set the Vertical Scale setting to the next value in the test record (2`mV, 5'mV, and so on, up to 1'V/div).
  - **b.** Repeat steps 7 on page 86 through 8 on page 86.
- **10.** Repeat all tests for the remaining input channels:
  - a. Double-tap the AC RMS measurement badge.
  - b. Tap the Configure panel.
  - **c.** Tap the **Source 1** field and select the next channel to test.
  - d. Double-tap the channel badge of the channel that you have finished testing and set Display to Off.
  - e. Tap the channel button on the digitizer Settings bar of the next channel to test.

- f. Double-tap the channel badge for the channel being tested.
- g. Starting at step 6 on page 86, repeat these procedures for each input channel.

#### Check random noise, High Res mode

This test checks random noise at 50  $\Omega$  for each channel in High Res acquisition mode. You do not need to connect any test equipment to the digitizer for this test.

- 1. Disconnect everything from the digitizer inputs.
- 2. Tap File > Default Setup.
- 3. Double-tap the Acquisition badge and set Acquisition Mode to High Res.
- 4. Add the AC RMS measurement:
  - a. Tap the Add New... Measure button to open the Add Measurements menu.
  - **b.** Set the **Source** to the channel being tested.
  - c. In the Amplitude Measurements panel, double-tap the AC RMS button to add the measurement badge to the Results bar.
  - d. Tap outside the menu to close it.
  - e. Double-tap the AC RMS measurement badge and tap Show Statistics in Badge to display statistics in the measurement badge.
  - Tap the Filter/Limit Results panel.
  - g. Turn on Limit Measurement Population.
  - h. Set the limit to 100.
  - i. Tap outside the menu to close it.
- 5. Set up the Horizontal mode:
  - a. Double-tap the Horizontal setting badge.
  - b. Set Horizontal Mode to Manual.
  - c. Set the Sample rate to 12.5 GS/s.
  - d. Set the Record Length to 2 Mpts.
  - e. Tap outside the menu to close it.
- **6.** Check **50**  $\Omega$  termination as follows:
  - a. In the Channel badge, set **Termination** to **50**  $\Omega$ .
  - b. Tap the Bandwidth Limit field and select 4`GHz or the highest frequency listed.
  - c. Set the channel Position value to 340 mdivs.
  - d. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the µ readout).
  - e. Set the channel Position value to -340 mdivs.
  - f. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the µ readout).
  - g. Average the two values and record the result in the 1 mV/div row of the 50  $\Omega$  column of the random noise, High Res mode Test Result record.
- 7. Repeat step 6 on page 87 for all frequencies below 4`GHz.
- **8.** Repeat 50  $\Omega$  tests at all V/div settings for the current channel:
  - a. In the Channel badge, set the Vertical Scale setting to the next value in the test record (2 mV, 5 mV, and so on, up to 1 V/div).
  - **b.** Repeat steps 6 on page 87 through 7 on page 87.
- **9.** Repeat all tests for the remaining input channels:
  - a. Double-tap the AC RMS measurement badge.
  - b. Tap the Configure panel.

- c. Tap the Source 1 field and select the next channel to test.
- d. Double-tap the channel badge of the channel that you have finished testing and set Display to Off.
- e. Tap the channel button on the digitizer Settings bar of the next channel to test.
- f. Double-tap the channel badge for the channel being tested.
- g. Starting at step 6 on page 87, repeat these procedures for each input channel.

## Check high offset AC RMS noise, Sample acquisition mode (8 and 6 GHz options)

This test checks high offset AC RMS noise at  $50 \Omega$  for each channel in sample acquisition mode. You do not need to connect any test equipment to the digitizer for this test.

- 1. Disconnect everything from the digitizer inputs.
- 2. Tap File > Default Setup.
- 3. Add the AC RMS measurement:
  - a. Tap the Add New... Measure button.
  - **b.** Set the **Source** to the channel being tested.
  - c. In the Amplitude Measurements panel, double-tap the AC RMS measurement button to add the measurement badge to the Results bar.
  - d. Tap outside the menu to close it.
  - e. Double-tap the AC RMS measurement badge and tap Show Statistics in Badge to display statistics in the measurement badge.
  - f. Tap the Filter / Limit Results panel.
  - g. Turn on Limit Measurement Population.
  - h. Set the limit to 100.
  - i. Tap outside the menu to close it.
- **4.** Set up the Horizontal mode:
  - a. Double-tap the Horizontal setting badge.
  - b. Set Horizontal Mode to Manual.
  - c. Set the Sample Rate to 25 GS/s.
  - d. Set the Record Length to 2 Mpts.
  - e. Tap outside the menu to close it.
- 5. Double-tap the Channel badge of the channel being tested.
- 6. Set the Vertical Scale value to 1 mV.
- 7. Check 50  $\Omega$  termination as follows:
  - a. In the Channel badge, set **Termination** to **50**  $\Omega$ .
  - **b.** Tap the **Bandwidth Limit** field and select the highest frequency listed.
  - c. Set the channel vertical Position value to 4 div.
  - **d.** Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the  $\mu$  readout).
  - **e.** Record the value in the **1 mV/div** row of the **50 Ω** column of the *High Offset AC RMS Noise*, sample acquisition mode test record.
- 8. Repeat step 7 on page 88 for all frequencies above 4 GHz
- **9.** Repeat the 50  $\Omega$  test at all V/div settings for the current channel:
  - a. In the Channel badge, set the Vertical Scale setting to the next value in the test record (2 mV/div through 1 V/div).
  - **b.** Repeat steps 7 on page 88 through 8 on page 88.
- 10. Repeat all tests for the remaining input channels:

- a. Double-tap the AC RMS measurement badge.
- b. Tap the Configure panel.
- c. Tap the Source 1 field and select the next channel to test.
- d. Double-tap the channel badge of the channel that you have finished testing and set Display to Off.
- e. Tap the channel button on the digitizer Settings bar of the next channel to test.
- f. Double-tap the channel badge for the channel being tested.
- g. Starting at step 6 on page 88, repeat these procedures for each input channel.

### Check high offset AC RMS noise, High Res mode

This test checks high offset AC RMS noise at 50  $\Omega$  for each channel in High Res acquisition mode. You do not need to connect any test equipment to the digitizer for this test.

- 1. Disconnect everything from the digitizer inputs.
- 2. Tap File > Default Setup.
- 3. Double-tap the Acquisition badge and set Acquisition Mode to High Res.
- 4. Add the AC RMS measurement:
  - a. Tap the Add New... Measure button to open the Add Measurements menu.
  - b. Set the **Source** to the channel being tested.
  - c. In the Amplitude Measurements panel, double-tap the AC RMS button to add the measurement badge to the Results bar.
  - d. Tap outside the menu to close it.
  - e. Double-tap the AC RMS measurement badge and tap Show Statistics in Badge to display statistics in the measurement badge.
  - Tap the Filter/Limit Results panel.
  - g. Turn on Limit Measurement Population.
  - h. Set the limit to 100.
  - i. Tap outside the menu to close it.
- 5. Set up the Horizontal mode:
  - a. Double-tap the Horizontal setting badge.
  - b. Set Horizontal Mode to Manual.
  - c. Set the Sample rate to 12.5 GS/s.
  - d. Set the Record Length to 2 Mpts.
  - e. Tap outside the menu to close it.
- **6.** Check **50**  $\Omega$  termination as follows:
  - a. In the Channel badge, set **Termination** to **50**  $\Omega$ .
  - b. Tap the Bandwidth Limit field and select 4`GHz or the highest frequency listed.
  - c. Set the channel Position value to 4 div.
  - d. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the µ readout).
  - e. Record the value in the 1 mV/div row of the 50 Ω column of the High Offset AC RMS Noise, High Res mode test record.
- 7. Repeat step 6 on page 89 for all frequencies below 4 GHz.
- **8.** Repeat 50  $\Omega$  tests at all V/div settings for the current channel:
  - a. In the Channel badge, set the Vertical Scale setting to the next value in the test record (2 div/mV through 1 V/div).
  - **b.** Repeat steps 6 on page 89 through 7 on page 89.
- 9. Repeat all tests for the remaining input channels:

- a. Double-tap the AC RMS measurement badge.
- b. Tap the Configure panel.
- c. Tap the Source 1 field and select the next channel to test.
- d. Double-tap the channel badge of the channel that you have finished testing and set Display to Off.
- e. Tap the channel button on the digitizer Settings bar of the next channel to test.
- f. Double-tap the channel badge for the channel being tested.
- g. Starting at step 6 on page 89, repeat these procedures for each input channel.

### Check long term samples rate and delay time accuracy

This test checks the sample rate and delay time accuracy (time base).

1. Connect a 50  $\Omega$  cable from the Aux Out connector to the frequency counter input as shown in the following figure.

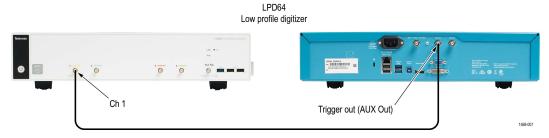


- 2. Tap File > Default Setup.
- 3. Tap Utility > I/O.
- 4. Tap AUX OUT to open its configuration menu.
- 5. Tap Reference Clock to send the clock to the Aux Out connector.
- 6. Check the reading on the frequency counter. Enter the value in the Test record.

# **Check AUX Out output voltage levels**

This test checks the output voltage levels from the AUX Out connector.

1. Use a 50  $\Omega$  cable to connect the AUX Out signal from the rear of the instrument to the channel 1 input of the same instrument, as shown in the following illustration.



- 2. Tap File > Default Setup. This resets the instrument and adds the channel 1 badge and signal to the display.
- 3. Double-tap the badge of the channel 1 badge to open its configuration menu.
- 4. Set the Vertical Scale to 1 V/div.

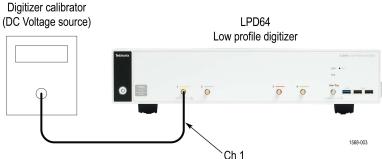
- 5. Tap outside the menu to close it.
- 6. Double-tap the Horizontal badge in the Settings bar.
- 7. Set the Horizontal Scale to 400 ns/div.
- 8. Tap outside the menu to close it.
- **9.** Record the Maximum and Minimum measurements at 50  $\Omega$  termination as follows:
  - a. Double-tap the Ch 1 badge to open its configuration menu.
  - b. Set Termination to 50  $\Omega$ .
  - c. Tap outside the menu to close it.
  - **d.** Enter the Maximum and Minimum measurement readings in the 50  $\Omega$  row of the test record.

## **Check DVM voltage accuracy (DC)**

This test checks the DC voltage accuracy of the Digital Volt Meter (DVM) option. The DVM option is available for free when you register the instrument at tek.com.

#### Procedure

1. Connect the digitizer to a DC voltage source to run this test. If using the Fluke 9500 calibrator as the DC voltage source, connect the



calibrator head to the digitizer channel to test.



**WARNING:** Set the generator output to Off or 0 volts before connecting, disconnecting, or moving the test hookup during the performance of this procedure. The generator is capable of providing dangerous voltages.

- 2. Set the calibrator impedance to 50  $\Omega$ .
- 3. Tap File > Default Setup. This resets the instrument and adds the channel 1 badge and signal to the display.
- **4.** Set the channel settings:
  - a) Double tap the badge of the channel under test to open its menu.
  - b) Check that **Position** is set to **0 divs**. If not, set the position to 0 divisions.
  - c) Set the Bandwidth Limit to 20 MHz.
- 5. Set the calibrator impedance to 50  $\Omega$ .
- 6. Double-tap the Horizontal badge and set Horizontal Scale to 1 ms/div.
- 7. Tap outside the menu to close it.
- 8. Double-tap the **Acquisition** badge and set the **Acquisition Mode** to **Average**.
- 9. Verify or set the Number of Waveforms to 16.
- 10. Tap outside the menu to close it.
- 11. Double-tap the **Trigger** badge and set the **Source** to **AC Line**.
- 12. Tap outside the menu to close it.
- 13. Tap the **DVM** button to add the DVM badge to the Results bar.
- **14.** In the **DVM** menu, set **Source** to the channel to be tested.

- 15. Set Mode to DC.
- **16.** Tap outside the menu to close it.
- 17. Set the calibrator to the input voltage shown in the test record (for example, -5 V for a 1V/div setting).
- **18.** In the channel under test menu, set the **Offset** value to that shown in the test record (for example, –5 V for –5 V input and 1'V/div setting).
- **19.** Set the **Vertical Scale** field to match the value in the test record (for example, 1 V/div).
- 20. Enter the measured value on the DVM badge into the DVM Voltage Accuracy Tests record.
- 21. Repeat the procedure (steps 17 on page 92, 18 on page 92, 19 on page 92 and 20 on page 92) for each volts/division setting shown in the test record.
- 22. Repeat all steps, starting with step 4 on page 91, for each digitizer channel to check. To set the next channel to test:
  - a) Double tap the badge of the channel under test to open its menu.
  - b) Set Display to Off.
  - c) Tap the channel button in the Settings bar of the next channel to test to add that channel badge and signal to the display.

## Check trigger frequency accuracy and maximum input frequency

This test checks trigger frequency counter accuracy. The trigger frequency counter is part of the free DVM and trigger frequency option that is available when you register the instrument at tek.com.

#### **Procedure**

- 1. Tap File > Default Setup to reset the instrument and add the channel 1 badge and signal to the display.
- 2. Connect the 10 MHz Reference out from the time mark generator to the Ref In connector on the back of the digitizer.
- 3. Connect the output of the time mark generator to the digitizer channel input being tested using a 50  $\Omega$  cable. Set the time mark generator to a 50  $\Omega$  source and a fast rising edge waveform ( $\geq$  3 mV/ns).
- 4. Set the time mark generator frequency to the first value shown in the test record, starting at 100 Hz.
- 5. Set the mark amplitude to  $1 V_{pp}$ , which makes a 2 divisions high waveform.
- **6.** Double-tap the channel badge being tested (starting with channel 1) and set **Termination** to **50**  $\Omega$ .
- 7. Set the channel Vertical Scale to 500 mV/div.
- 8. Tap outside the menu to close it.
- 9. Double-tap the Acquisition badge and set the Timebase Reference Source to .
- **10.** Tap outside the menu to close it.
- 11. Double-tap the Horizontal badge and use the Horizontal Scale controls to display at least 2 cycles of the waveform.
- 12. Tap outside the menu to close it.
- 13. Double-tap the Trigger badge to open its menu.
  - a) Set the **Source** field to the input channel being tested.
  - b) Tap the **Set to 50%** button to obtain a stable display.
  - c) Tap the **Mode & Holdoff** panel to open the **Mode & Holdoff** configuration menu.
  - d) In the **Mode & Hold Off** menu, set the **Trigger Frequency Counter** to **On**. The trigger frequency readout is at the bottom of the Trigger badge.
  - e) Tap outside the menu to close it.
- **14.** Double-tap the channel badge being tested (starting with channel 1) and use the **Position** controls to vertically center the time mark in the waveform graticule.
- 15. Enter the value of the trigger frequency (F readout in the Trigger badge) in the test record for that frequency.

- **16.** Repeat this procedure for each frequency setting shown in the record. Make sure to adjust the Horizontal scale after each calibrator frequency change to show at least two cycles of the waveform on the screen.
- 17. Repeat all these steps to test each digitizer channel.

#### Check AFG sine and ramp frequency accuracy

This test verifies the frequency accuracy of the arbitrary function generator. All output frequencies are derived from a single internally generated frequency. Only one frequency point of channel 1 is required to be checked.

1. Connect a 50 Ω cable from the AFG Out connector to the frequency counter input as shown in the following figure.

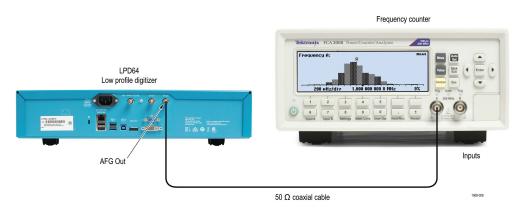


Figure 1: Frequency/period test

- 2. Tap File > Default Setup to set the instrument to the factory default settings.
- 3. Tap the AFG button to open the AFG menu.
- 4. Set the arbitrary function generator output as follows:

Select menu	Setting
Output	On
Waveform Type	Sine
Frequency	1.000000 MHz
Amplitude	1.00 V <sub>PP</sub>

- 5. Turn on the frequency counter:
  - a. Double-tap the Trigger badge to open its menu.
  - b. Set the Source field to the input channel being tested.
  - c. Tap the Set to 50% button to obtain a stable display.
  - d. Tap the Mode & Holdoff panel to open the Mode & Holdoff configuration menu
  - **e.** In the Mode & Hold Off menu, set the **Trigger Frequency Counter** to **On**. The trigger frequency readout is at the bottom of the Trigger badge.
  - f. Tap outside the menu to close it.
- 6. Check that the reading of the frequency counter is between 0.999950 MHz and 1.000050 MHz. Enter the value in the Test record.
- 7. Set the arbitrary function generator output as follows:

Select menu	Setting
Waveform Type	Ramp
Frequency	500 kHz

8. Check that reading of the frequency counter is between 499.975 kHz and 500.025 kHz. Enter the value in the Test record.

## Check AFG square and pulse frequency accuracy

This test verifies the frequency accuracy of the arbitrary function generator. All output frequencies are derived from a single internally generated frequency. Only one frequency point of channel 1 is required to be checked.

1. Connect the arbitrary function generator to the frequency counter as shown in the following figure.

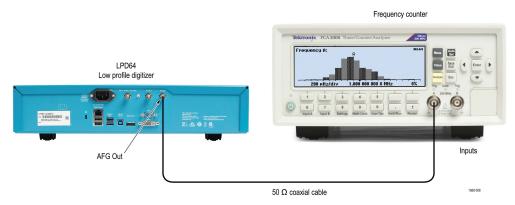


Figure 2: Frequency/period test

- 2. Tap File > Default Setup to set the instrument to the factory default settings.
- 3. Tap the AFG button to open the AFG menu.
- **4.** Set the arbitrary function generator as follows:

Select menu	Setting
Waveform Type	Square
Frequency	1.000000 MHz
Amplitude	1.00 V <sub>PP</sub>
Output	On

- 5. Turn on the frequency counter:
  - a. Double-tap the Trigger badge to open its menu.
  - b. Set the Source field to the input channel being tested.
  - c. Tap the Set to 50% button to obtain a stable display.
  - d. Tap the Mode & Holdoff panel to open the Mode & Holdoff configuration menu
  - **e.** In the Mode & Hold Off menu, set the **Trigger Frequency Counter** to **On**. The trigger frequency readout is at the bottom of the Trigger badge.
  - f. Tap outside the menu to close it.
- 6. Check that the frequency counter readout is between 0.999950 MHz and 1.00005 MHz. Enter the value in the Test record.
- 7. Set up the arbitrary function generator as follows:

Select menu	Setting
Waveform Type	Pulse

8. Check that reading of the frequency counter is between 0.999950 MHz and 1.000050 MHz. Enter the value in the Test record.

## **Check AFG signal amplitude accuracy**

This test verifies the amplitude accuracy of the arbitrary function generator. All output amplitudes are derived from a combination of attenuators and 3 dB variable gain. Some amplitude points are checked. This test uses a 50  $\Omega$  terminator. It is necessary to know the accuracy of the 50  $\Omega$  terminator in advance of this amplitude test. This accuracy is used as a calibration factor.

1. Connect the 50  $\Omega$  terminator to the DMM as shown in the following figure and measure the resistance value.

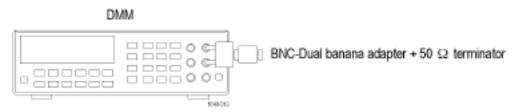


Figure 3: 50 Ω terminator accuracy

**2.** Calculate the 50  $\Omega$  calibration factor (CF) from the reading value and record as follows:

Table 8: CF (Calibration Factor) =  $1.414 \times ((50 / \text{Measurement }\Omega) + 1)$ 

Measurement (reading of the DMM)	Calculated CF

#### Examples:

For a measurement of 50.50  $\Omega$ , CF = 1.414 ( 50 / 50.50 + 1) = **2.814**.

For a measurement of 49.62  $\Omega$ , CF = 1.414 ( 50 / 49.62 + 1) = **2.839**.

3. Connect the arbitrary function generator output to the DMM as shown in the following figure. Be sure to connect the 50  $\Omega$  terminator to the AFG Out connector.



Figure 4: Amplitude test

4. Tap the AFG button and set up the arbitrary function generator output as follows:

Select menu	Setting	
Waveform Type	Sine	
Frequency	1.000000 kHz	
Amplitude	30 mV <sub>PP</sub>	
Load Impedance	50 Ω	
Output	On	

5. Measure the AC RMS voltage readout on the DMM.

- **6.** Multiply the DMM voltage by the calculated CF to get the corrected peak to peak voltage. Enter the resulting value in the Measurement field in the following table.
- 7. Change the AFG output amplitude to the next value in the table.
- 8. Repeat steps 5 on page 95 through 7 on page 96 for each amplitude value. Check that the peak to peak voltages are within the limits in the table below. Enter the values in the test record.

Waveform Type	Frequency	Amplitude	Measurement	Range
Sine	1.000 kHz	30.0 mV <sub>PP</sub>		28.55 mV <sub>PP</sub> - 31.45`mV <sub>PP</sub>
Sine	1.000 kHz	300.0 mV <sub>PP</sub>		294.5 mV <sub>PP</sub> - 305.5`mV <sub>PP</sub>
Sine	1.000 kHz	800.0 mV <sub>PP</sub>		787.0 mV <sub>PP</sub> - 813.0`mV <sub>PP</sub>
Sine	1.000 kHz	1.500 V <sub>PP</sub>		1.4765 V <sub>PP</sub> - 1.5235`V <sub>PP</sub>
Sine	1.000 kHz	2.000 V <sub>PP</sub>		1.969 V <sub>PP</sub> - 2.031 V <sub>PP</sub>
Sine	1.000 kHz	2.500 V <sub>PP</sub>		2.4615 V <sub>PP</sub> - 2.5385`V <sub>PP</sub>

## **Check AFG DC offset accuracy**

This test verifies the DC offset accuracy of the arbitrary function generator. This test uses a 50  $\Omega$  terminator. It is necessary to know the accuracy of the 50  $\Omega$  terminator in advance of this test. This accuracy is used as a calibration factor.

1. Connect the 50  $\Omega$  terminator to the DMM as shown in the following figure and measure the resistance value.

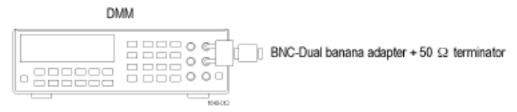


Figure 5: 50 Ω terminator accuracy

**2.** Calculate the 50  $\Omega$  calibration factor (CF) from the reading value and record as follows:

Table 9: CF (Calibration Factor) =  $0.5 \times ((50 / \text{Measurement }\Omega) + 1)$ 

Measurement (reading of the DMM)	Calculated CF

#### Examples:

For a measurement of 50.50  $\Omega$ , CF = 0.5 ( 50 / 50.50 + 1) = **0.9951**.

For a measurement of 49.62  $\Omega$ , CF = 0.5 ( 50 / 49.62 + 1) = **1.0038**.

3. Connect the arbitrary function generator output to the DMM as shown in the following figure. Be sure to connect the 50  $\Omega$  terminator to the arbitrary function generator **AFG Output** connector.

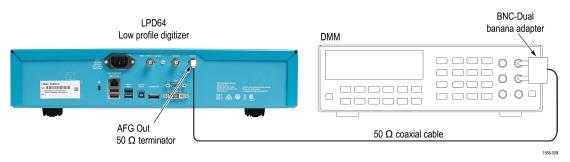


Figure 6: DC offset tests

**4.** Tap the **AFG** button and set up the arbitrary function generator as follows:

Select menu	Setting
Waveform Type	DC
Offset	+ 1.25 V
Output	On

- 5. Measure the voltage readout on the DMM.
- **6.** Multiply the DMM voltage by the calculated CF to get the corrected offset voltage. Enter the resulting value in the Measurement field in the following table.

Function	Offset	Measurement	Range
DC	+ 1.25 Vdc	Vdc	1.23025 Vdc to 1.26975 Vdc
DC	0.000 Vdc	Vdc	- 0.001 Vdc to + 0.001 Vdc
DC	- 1.25 Vdc	Vdc	-1.26975 Vdc to -1.23025 Vdc

- 7. Change the AFG output amplitude to the next value in the table, measure the voltage readout on the DMM, multiply the DMM readout by the calculated CF to get the corrected offset voltage, and enter the resulting value in the Measurement field in the table.
- 8. Verify that the corrected offset measurements are within the range.